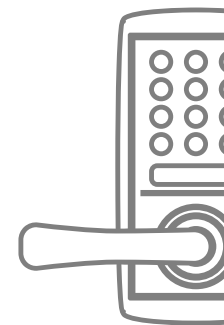
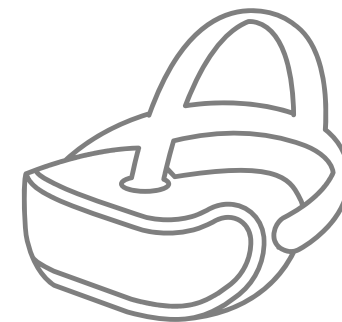
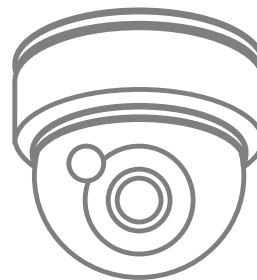
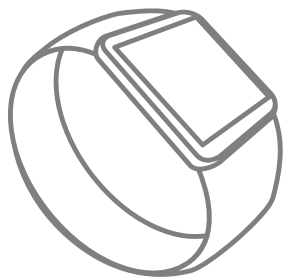
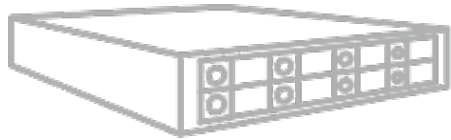
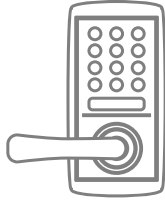
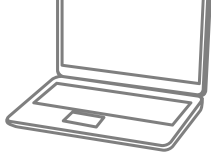


# Server

Solution Proposal by Toshiba

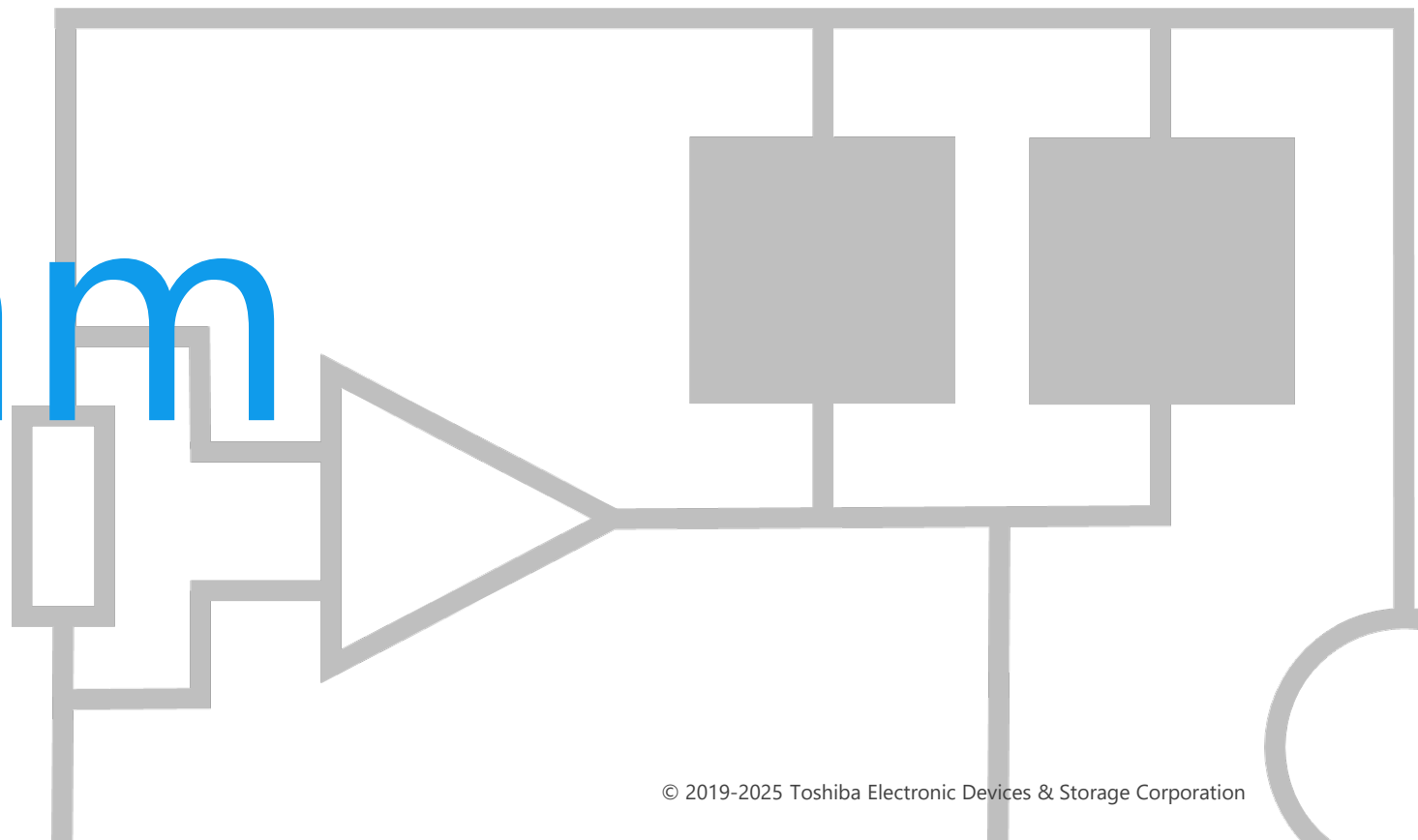




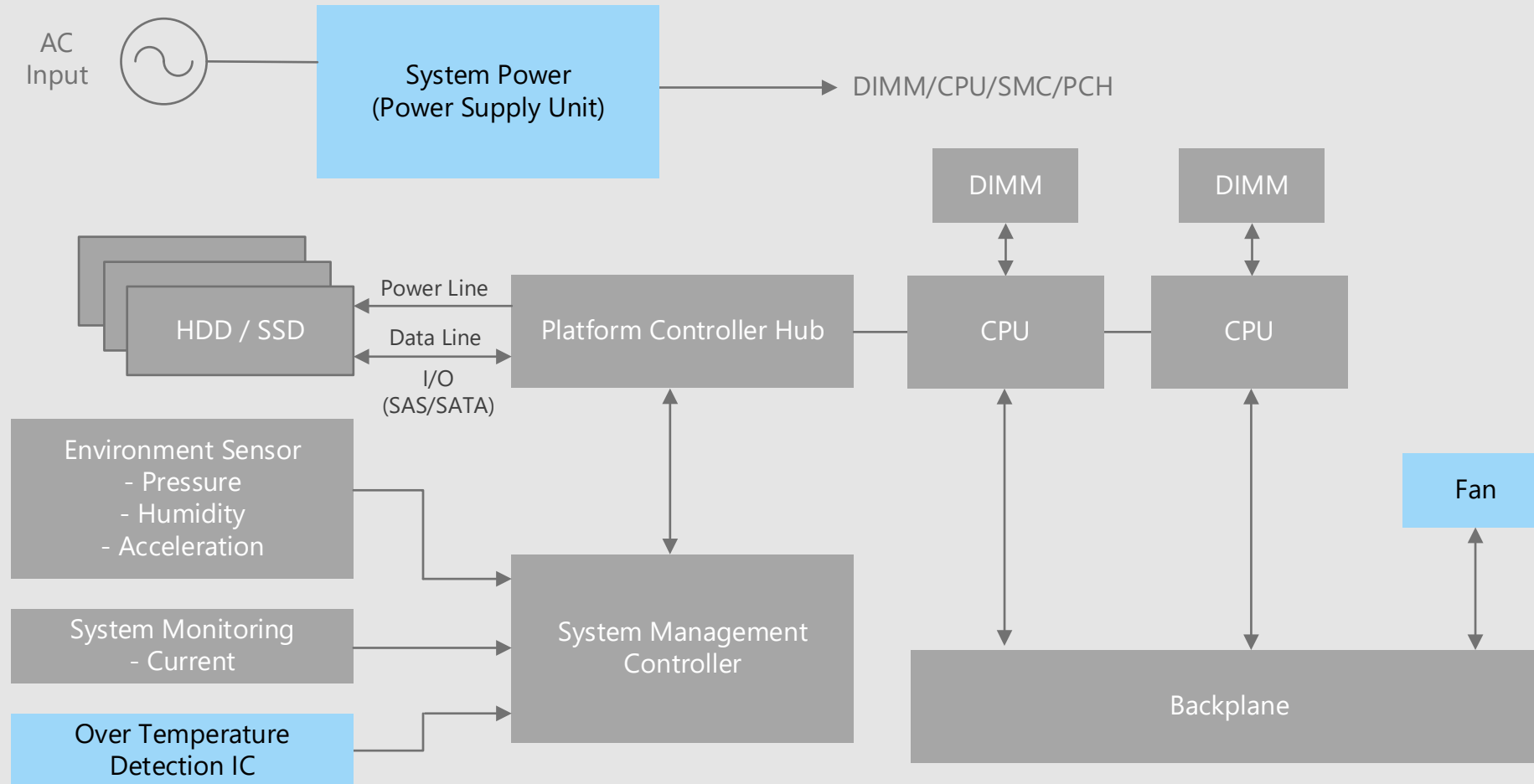
Toshiba Electronic Devices & Storage Corporation provides comprehensive device solutions to customers developing new products by applying its thorough understanding of the systems acquired through the analysis of basic product designs.



# Block Diagram

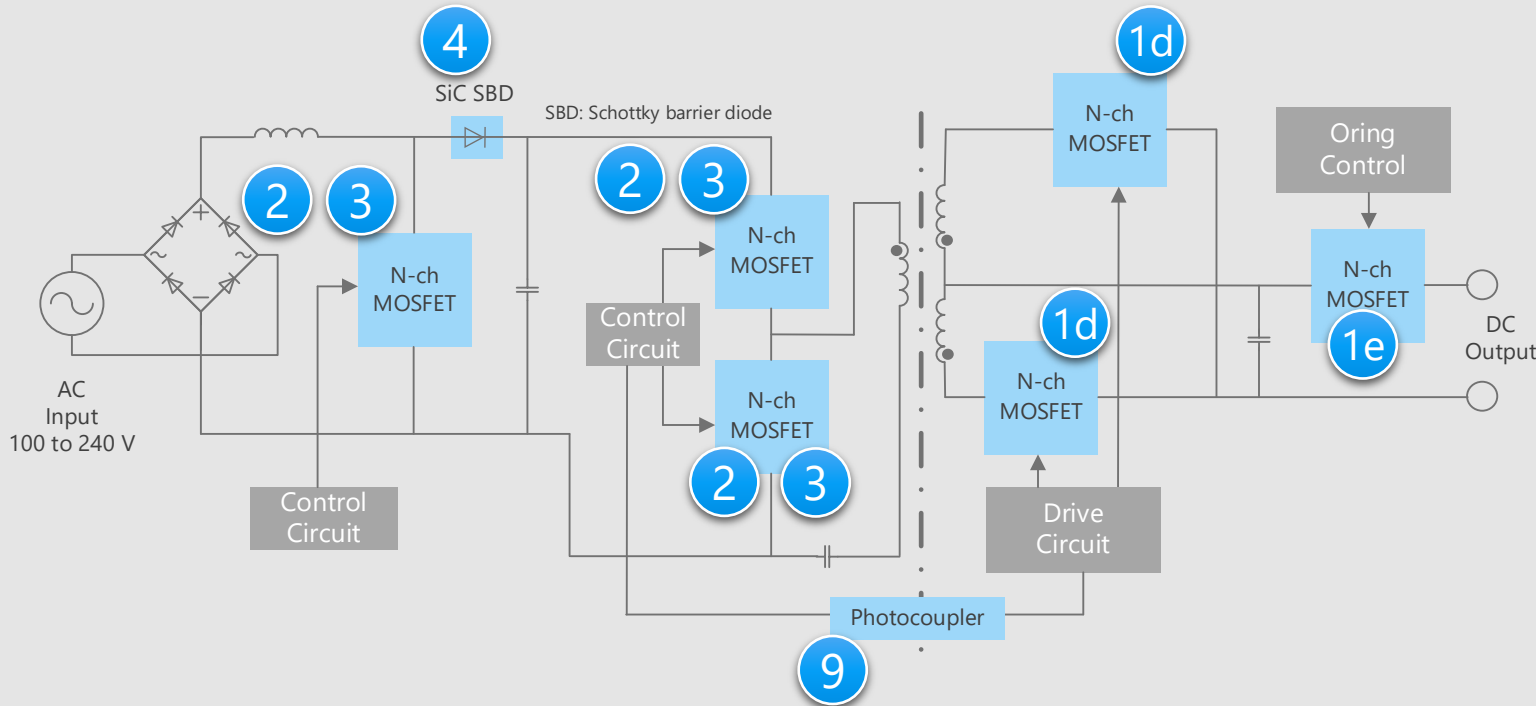


# Server Overall block diagram



# Server Detail of power supply circuit (1)

## AC-DC converter for 48 V system



\* Click the number in the circuit diagram to jump to the detailed description page.

Reference Designs of power supply circuits from here →

[Click Here](#)

## Criteria for device selection

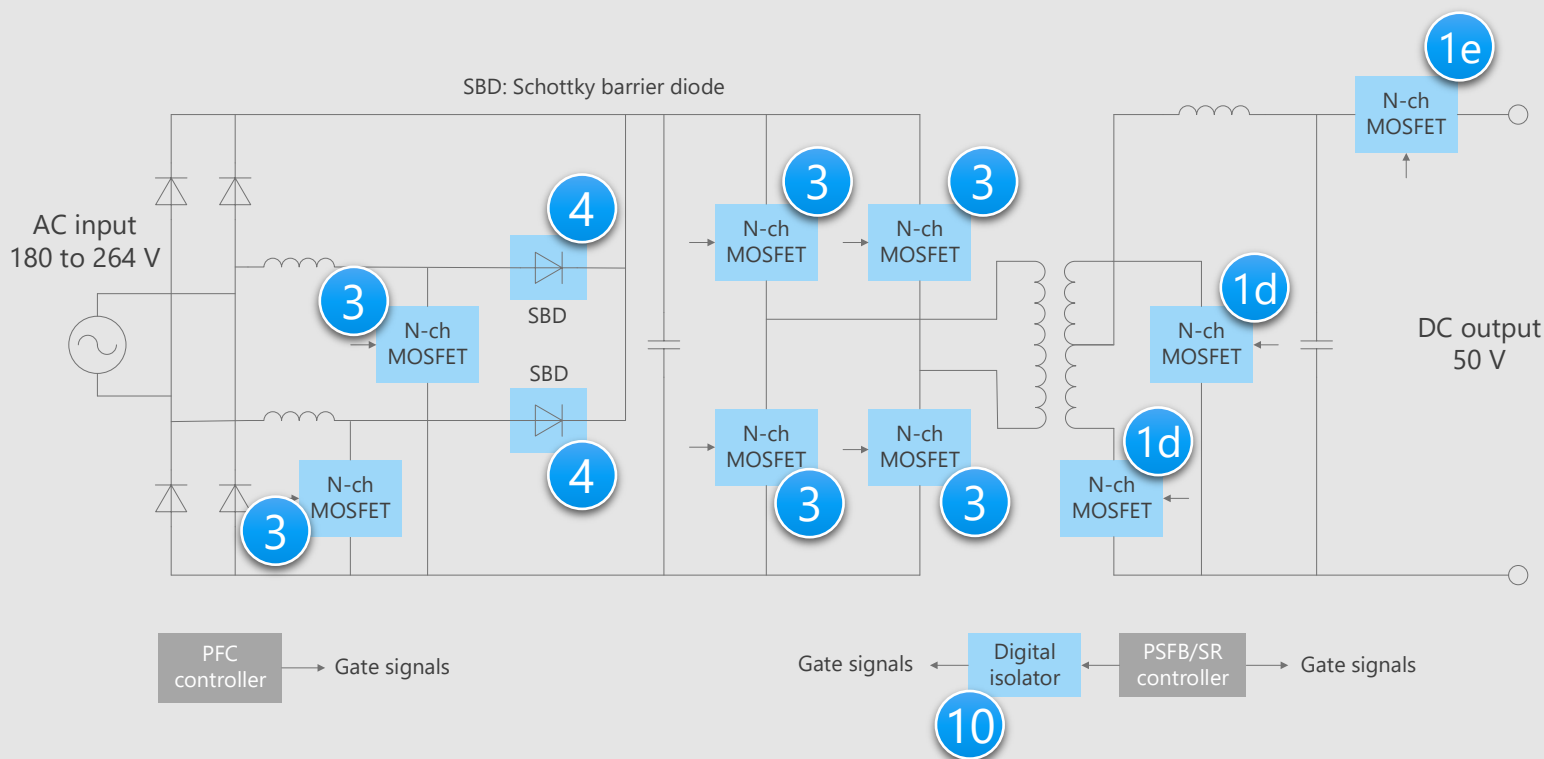
- A MOSFET having a high voltage and a low on-resistance is suitable for the AC-DC power supply circuit.
- An IC output photocoupler for high speed communication is used for isolation and transmission of control signals between the primary and the secondary side in the AC-DC power supply.

## Proposals from Toshiba

- **Suitable for efficient switching of power supply**
  - U-MOS Series MOSFET
  - DTMOS Series MOSFET
  - SiC MOSFET
- **Suitable for high efficiency and miniaturization of power supply**
  - SiC Schottky barrier diode
- **Realize high speed isolated signal transmission**
  - IC output photocoupler for high speed communication

# Server Detail of power supply circuit (2)

## 3 kW AC-DC converter for 48 V system



\* Click the number in the circuit diagram to jump to the detailed description page.

Reference Design with detailed information from here →

[Click Here](#)

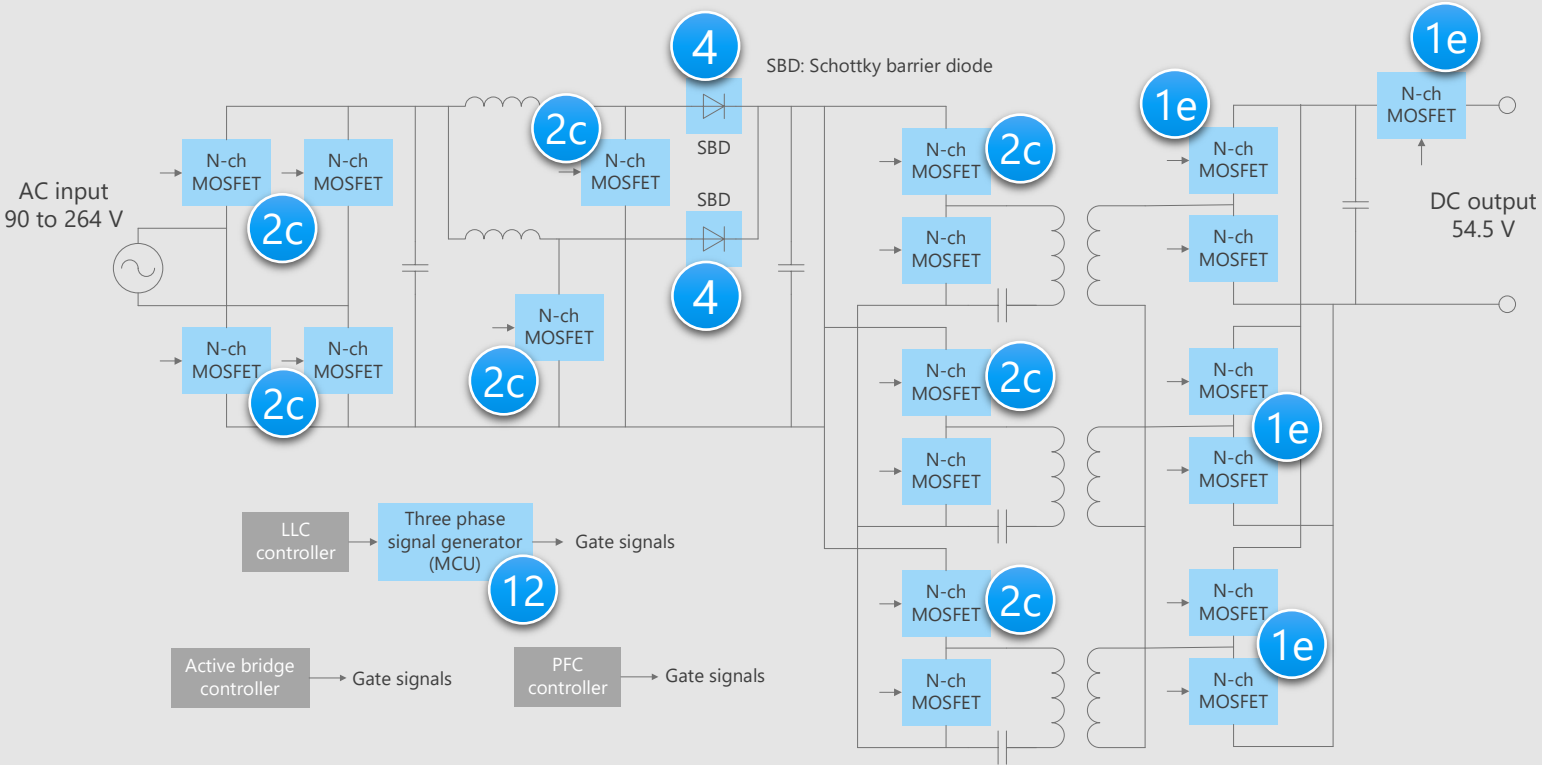
## Criteria for device selection

- A MOSFET having a high voltage and a low on-resistance is suitable for the AC-DC power supply circuit.
- The standard digital isolator is used for isolation and high speed transmission of control signals between the primary and the secondary side in the AC-DC power supply.

## Proposals from Toshiba

- **Suitable for efficient switching of power supply**  
U-MOS Series MOSFET  
SiC MOSFET
- **Suitable for high efficiency and miniaturization of power supply**  
SiC Schottky barrier diode
- **Realize high speed isolated signal transmission**  
Standard digital isolator

## 1.6 kW LLC AC-DC converter for 48 V system



\* Click the number in the circuit diagram to jump to the detailed description page.

Reference Design with detailed information from here →

[Click Here](#)

## Criteria for device selection

- A MOSFET having a high voltage and a low on-resistance is suitable for the AC-DC power supply circuit.

## Proposals from Toshiba

- Suitable for efficient switching of power supply

# U-MOS Series MOSFET

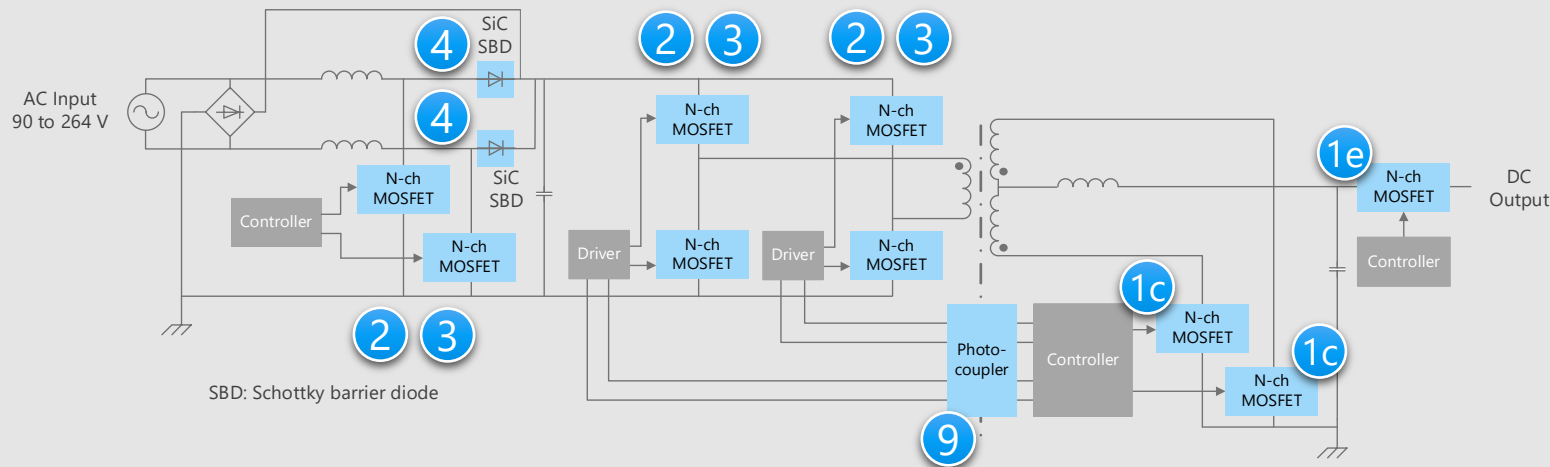
DTMOS Series MOSFET

- **Suitable for high efficiency and miniaturization of power supply**  
SiC Schottky barrier diode

- **Output three-phase PWM signal**  
MCU TPM372FWUG

# Server Detail of power supply circuit (4)

## 1.6 kW AC-DC converter for 12 V system (bridgeless PFC)



\* Click the number in the circuit diagram to jump to the detailed description page.

Reference Design with detailed information from here →

[Click Here](#)

## Criteria for device selection

- A MOSFET having a high voltage and a low on-resistance is suitable for the PFC circuit of the AC-DC power supply.
- An IC output photocoupler for high speed communication is used for signal isolation and transmission of feeding back voltages to the primary in the AC-DC power supply.

## Proposals from Toshiba

- **Suitable for efficient switching of power supply**

U-MOS Series MOSFET

DTMOS Series MOSFET

SiC MOSFET

- **Suitable for high efficiency and miniaturization of power supply**

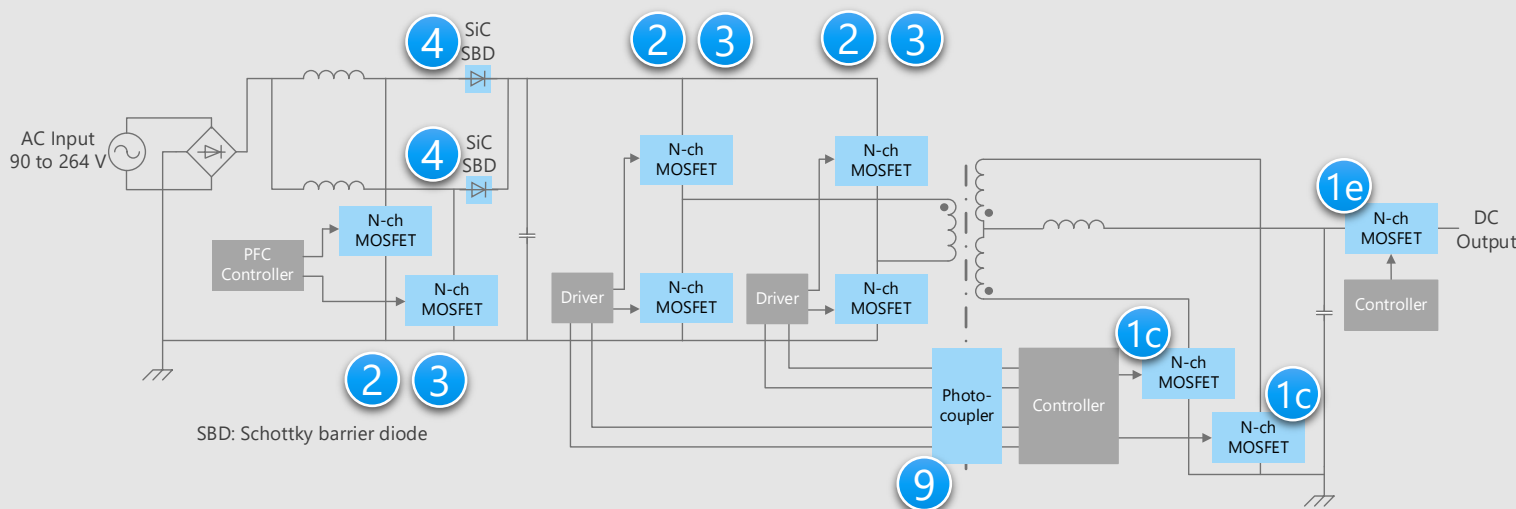
SiC Schottky barrier diode

- **Realize high speed isolated signal transmission**

IC output photocoupler

for high speed communication

## 1.6 kW AC-DC converter for 12 V system (interleaved PFC)



\* Click the number in the circuit diagram to jump to the detailed description page.

## Criteria for device selection

- A MOSFET having a high voltage and a low on-resistance is suitable for the PFC circuit of the AC-DC power supply.
- The IC output photocoupler for high speed communication is used for feeding back voltages to the primary in the AC-DC power supply.

## Proposals from Toshiba

- **Suitable for efficient switching of power supply**

U-MOS Series MOSFET

DTMOS Series MOSFET

SiC MOSFET

- **Suitable for high efficiency and miniaturization of power supply**

SiC Schottky barrier diode

- **Realize high speed isolated signal transmission**

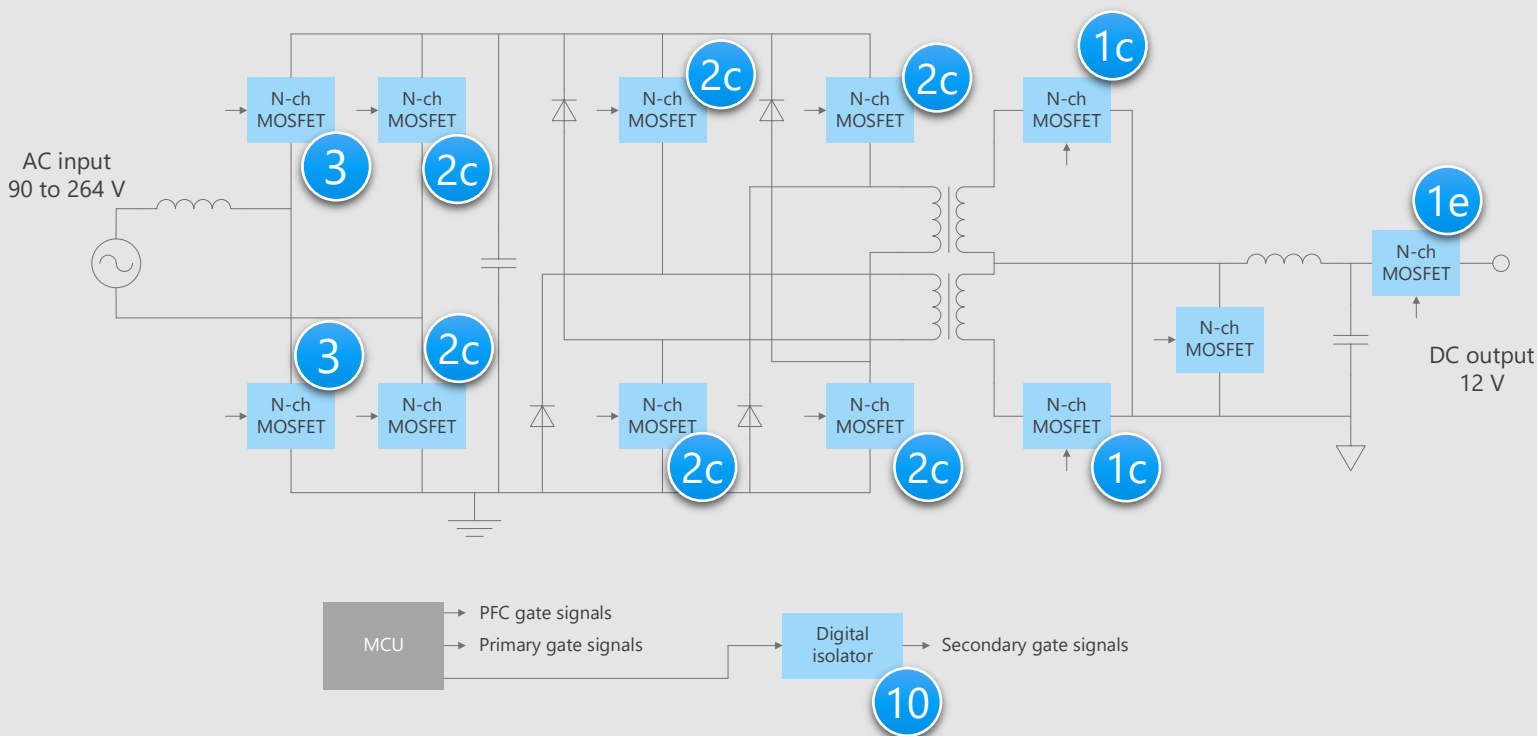
IC output photocoupler

for high speed communication

# Server Detail of power supply circuit (6)

## 1.1 kW ITTF (Interleaved Two Transistor Forward)

### AC-DC converter for 12 V system



\* Click the number in the circuit diagram to jump to the detailed description page.

Reference Design with detailed information from here →

[Click Here](#)

## Criteria for device selection

- A MOSFET having a high voltage and a low on-resistance is suitable for the AC-DC power supply circuit
- The standard digital isolator is used for isolation and high speed transmission of control signals between the primary and the secondary side in the AC-DC power supply.

## Proposals from Toshiba

- **Suitable for efficient switching of power supply**

U-MOS Series MOSFET

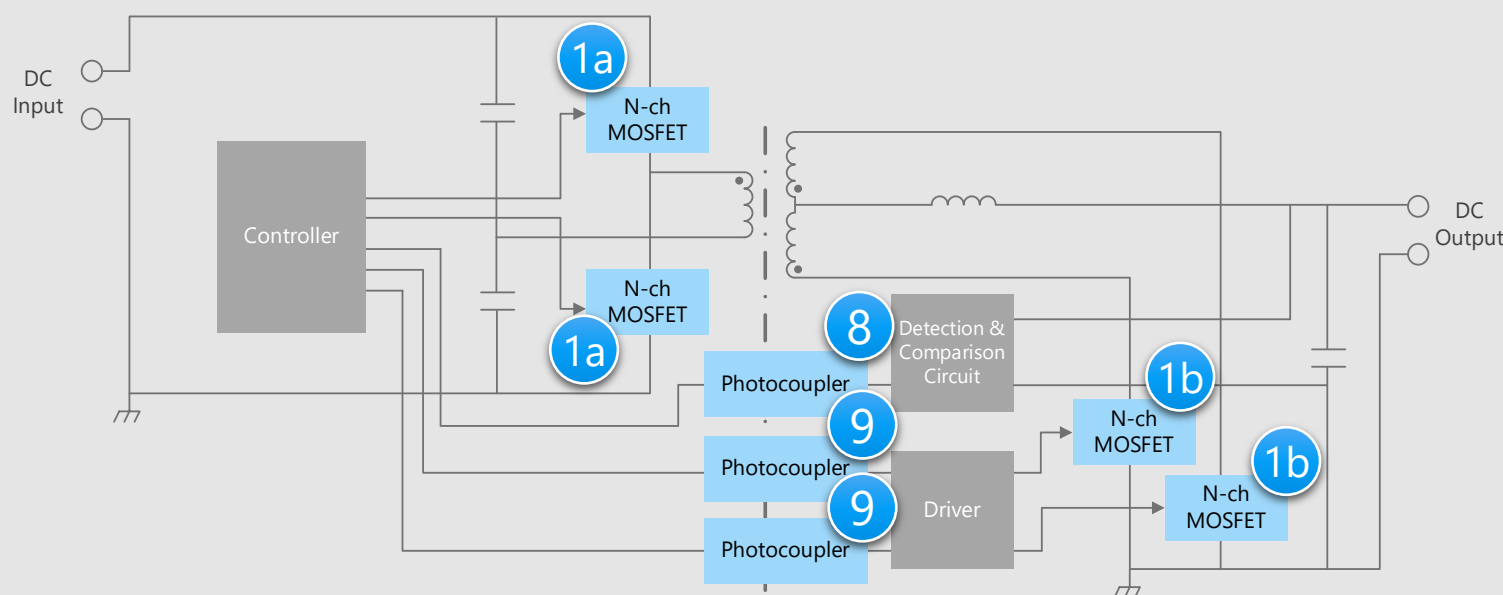
DTMOS Series MOSFET

SiC MOSFET

- **Realize high speed isolated signal transmission**

Standard digital isolator

## 1.2 V / 100 A output DC-DC converter for 48 V bus system



\* Click the number in the circuit diagram to jump to the detailed description page.

Reference Design with detailed information from here →

[Click Here](#)

## Criteria for device selection

- A MOSFET having a high speed and a low on-resistance is suitable for the DC-DC power supply.
- A transistor output photocoupler is typically used for feeding back voltages to the primary in the DC-DC power supply.
- The IC output photocoupler for high speed communication is used for signal isolation.

## Proposals from Toshiba

- **Suitable for efficient switching of power supply**

U-MOS Series MOSFET

1a 1b

- **Realize high speed isolated signal transmission**

Transistor output photocoupler

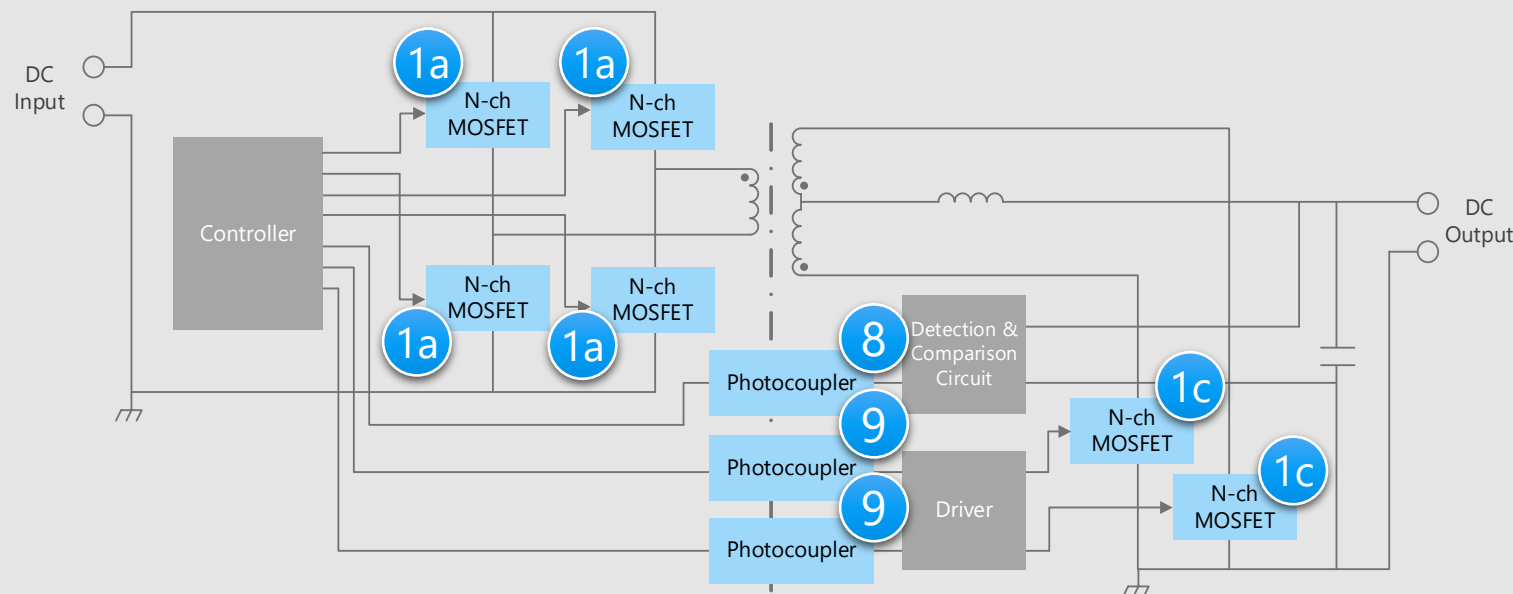
8

IC output photocoupler

9

for high speed communication

## 300 W isolated DC-DC converter for 48 V system



\* Click the number in the circuit diagram to jump to the detailed description page.

Reference Design with detailed information from here →

[Click Here](#)

## Criteria for device selection

- A MOSFET having a high speed and a low on-resistance is suitable for the DC-DC power supply.
- A transistor output photocoupler is typically used for feeding back voltages to the primary in the DC-DC power supply.
- The IC output photocoupler for high speed communication is used for signal isolation.

## Proposals from Toshiba

- **Suitable for efficient switching of power supply**

U-MOS Series MOSFET

1a 1c

- **Realize high speed isolated signal transmission**

Transistor output photocoupler

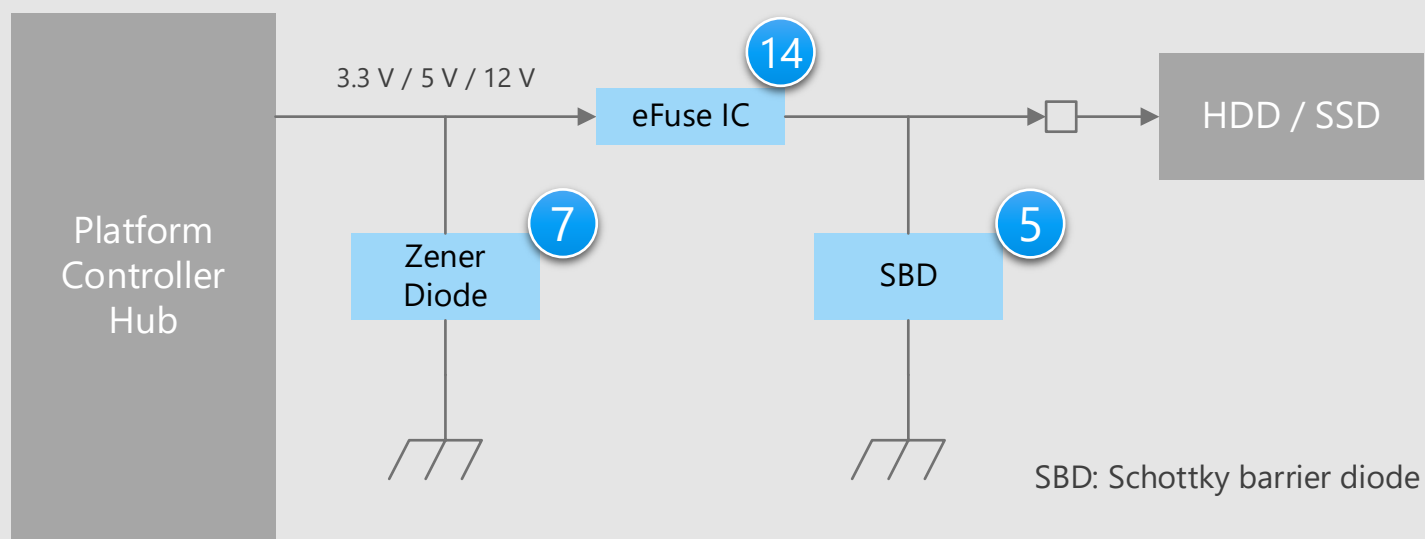
8

IC output photocoupler

9

for high speed communication

## Power line to storage devices



\* Click the number in the circuit diagram to jump to the detailed description page.

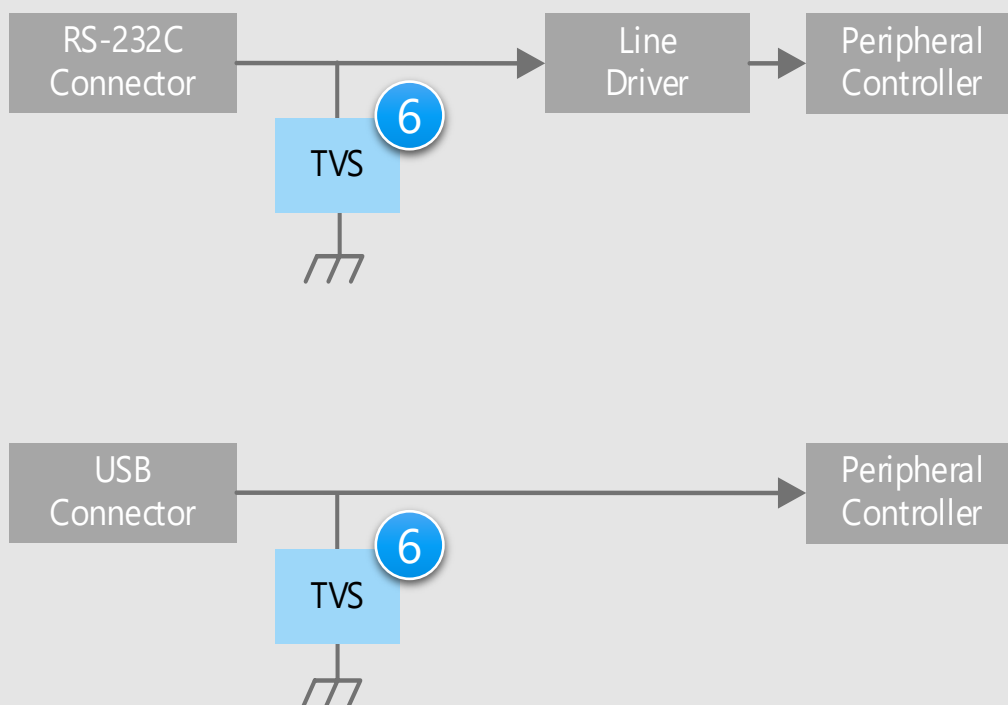
## Criteria for device selection

- eFuse IC protects devices from overcurrent and overvoltage caused by hot-swapping or accidental short circuits.
- Zener diode is suitable for protection against spike voltages that occur during hot-swapping.
- Schottky barrier diode (SBD) is effective against negative spike voltages that occur on the output side.

## Proposals from Toshiba

- **Built-in protection function against short circuit, over current, over voltage, etc.**  
Electronic fuse (eFuse IC) 14
- **Suppress input spike voltage**  
Zener diode 7
- **Low  $V_f$  suppresses negative voltage surges**  
Schottky barrier diode 5

## Peripheral interface circuits



\* Click the number in the circuit diagram to jump to the detailed description page.

## Criteria for device selection

- To improve the reliability of the set, ESD protection is required for connectors that may come into contact with the human body.
- Small TVS diodes with low terminal capacitance are suitable for ESD protection.

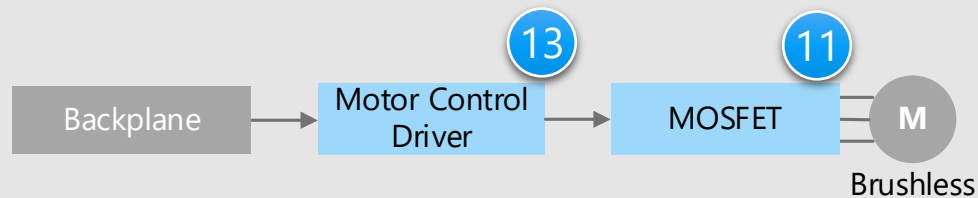
## Proposal from Toshiba

- **Absorb static electricity from external terminals to prevent malfunction of the circuit and device breakdown**

TVS diode

6

## Fan drive circuit



\* Click the number in the circuit diagram to jump to the detailed description page.

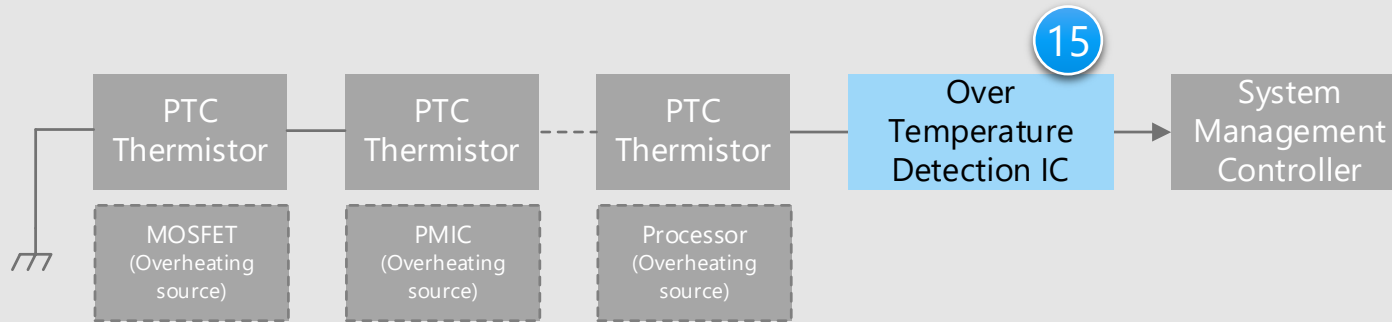
## Criteria for device selection

- By using brushless DC motor drivers, three-phase brushless DC motors can be controlled easily.

## Proposals from Toshiba

- **Easy control of motors**  
Three-phase brushless DC motor driver IC 13
- **Suitable for high efficiency switching**  
Semi-power MOSFET 11

## Over temperature monitoring circuit



## Criteria for device selection

- Over temperature monitoring is required at multiple points on the circuit board such as MOSFET, PMIC and Processor.
- Low power dissipation of set can be realized by using the over temperature detection IC with low current consumption.
- Small package products contribute to the reduction of circuit board area.

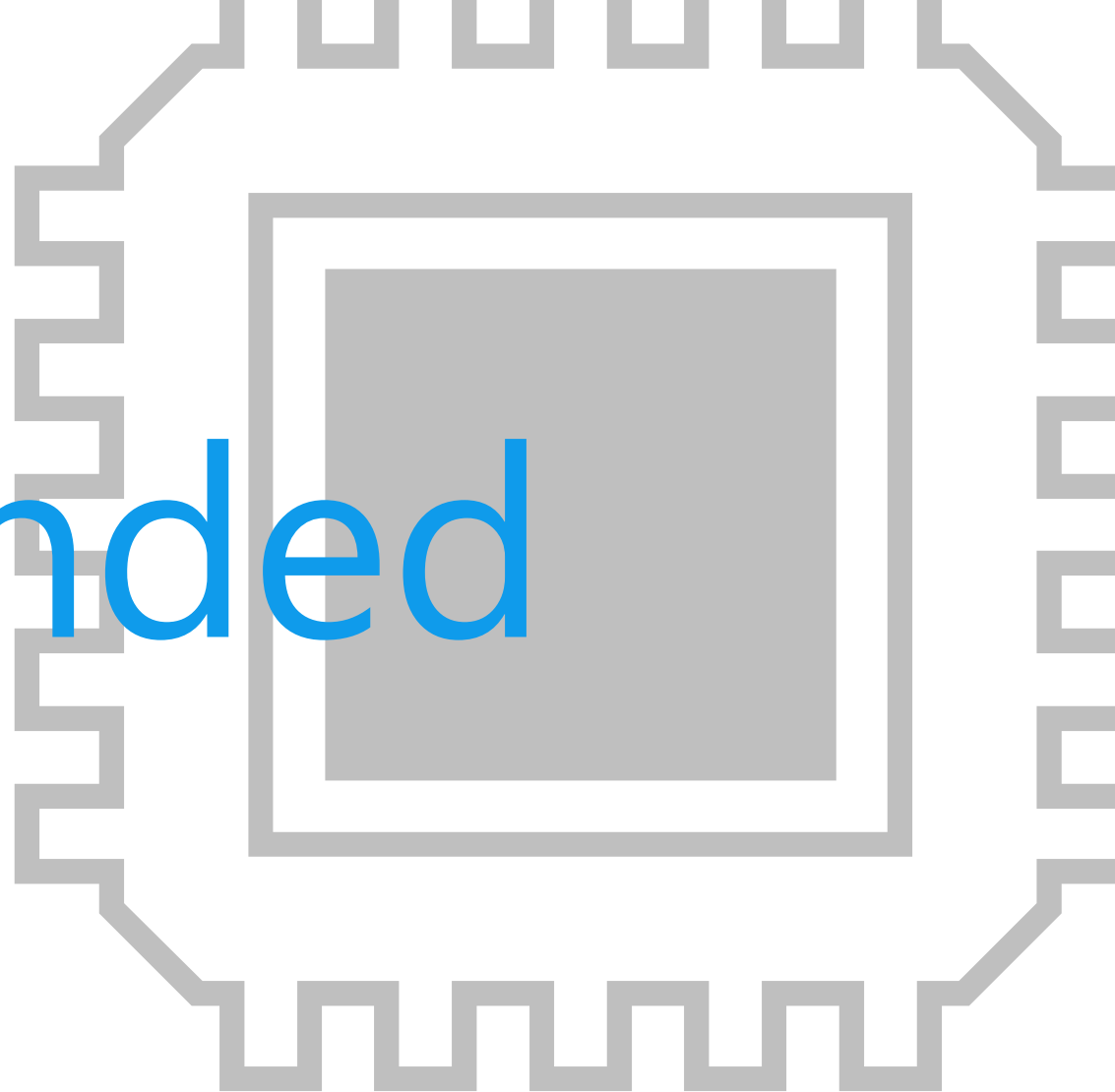
## Proposal from Toshiba

- **Monitor temperature at multiple points with small package and low current consumption**

Over temperature detection IC  
(Thermoflagger™)

\* Click the number in the circuit diagram to jump to the detailed description page.

# Recommended Devices



# Device solutions to address customer needs

As described above, in the design of the server system, "**Low power consumption and low heat generation**", "**Improved set reliability**" and "**Miniaturization of circuit boards**" are important factors. Toshiba's proposals are based on these three solution perspectives.



# Device solutions to address customer needs

Low power consumption  
Low heat generation  
High heat dissipation efficiency

Noise immunity

Small size packages

①	<b>U-MOS Series MOSFET</b>	●		●
②	<b>DTMOS Series MOSFET</b>	●		●
③	<b>SiC MOSFET</b>	●	●	
④	<b>SiC Schottky barrier diode</b>	●	●	●
⑤	<b>Schottky barrier diode</b>	●		●
⑥	<b>TVS diode</b>		●	●
⑦	<b>Zener diode</b>		●	●
⑧	<b>Transistor output photocoupler</b>		●	●
⑨	<b>IC output photocoupler for high speed communication</b>		●	●
⑩	<b>Standard digital isolator</b>		●	●

# Device solutions to address customer needs

Low power consumption  
Low heat generation  
High heat dissipation efficiency

Noise immunity

Small size packages

11 Semi-power MOSFET



12 MCU



13 Three-phase brushless DC motor driver IC



14 Electronic fuse (eFuse IC)



15 Over temperature detection IC  
(Thermoflagger™)



Value provided

Improved on-resistance and switching characteristic contribute to realizing the set with high efficiency.

## 1 Low on-resistance

Reduction of  $R_{DS(ON)}$  makes heat generation and power consumption small.  $R_{DS(ON)}$  has been reduced by 42% compared to Toshiba's existing 150 V MOSFETs. [Note 1]

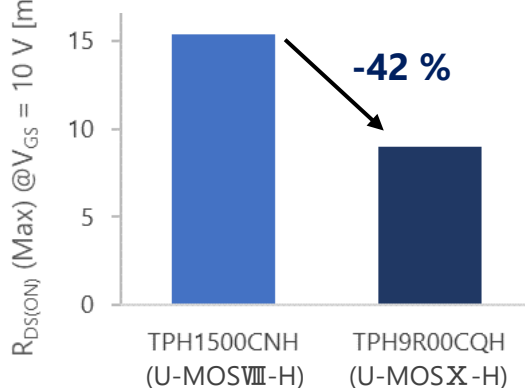
## 2 Small gate switch charge $Q_{SW}$

The  $Q_{SW}$  is small and contributes to the reduction of switching loss. The  $R_{DS(ON)} \times Q_{SW}$  has been reduced by 16% compared to that of competitor's 150 V MOSFETs. [Note 2]

## 3 Wide variety of packages

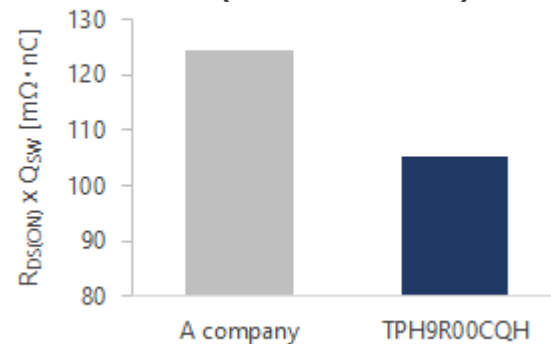
5 x 6 mm sized SOP Advance(N) package and 3 x 3 mm sized TSON Advance package are available. Suitable packages for various applications can be selected.

Comparison of on-resistance  
(150 V MOSFETs)





[Note 1] Toshiba internal comparison

Comparison of  $R_{DS(ON)} \times Q_{SW}$   
(150 V MOSFETs)



[Note 2] Comparison with competitor's product with equivalent ratings.  
As of June, 2023. Based on Toshiba's measurement data.

Lineup

Part number	TPH9R00CQH	TPN12008QM	TPN1200APL
Package	SOP Advance / SOP Advance(N) 	TSON Advance 	
Package size [mm]	5 x 6 / 4.9 x 6.1	3 x 3	
$V_{DSS}$ [V]	150	80	100
$I_D$ [A]	64 (108*)	26 (60*)	40 (66*)
$R_{DS(ON)}$ [mΩ] @ $V_{GS} = 10 \text{ V}$	Typ.	7.3	9.6
	Max	9.0	12.3
Generation	U-MOSIX-H	U-MOSIX-H	U-MOSIX-H

\*: Silicon limit

[Return to Block Diagram TOP](#)

Value provided

Improved on-resistance and output charge characteristic contribute to realizing the set with high efficiency.

## 1 Low on-resistance

Reduction of  $R_{DS(ON)}$  makes heat generation and power consumption small.  $R_{DS(ON)}$  has been reduced by 21% compared to Toshiba's existing 40 V MOSFETs. [Note 1]

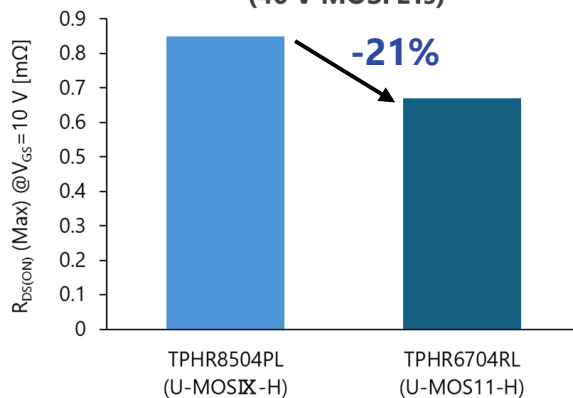
## 2 Small output charge $Q_{OSS}$

The  $Q_{OSS}$  is small and contributes to the reduction of output charge loss. The  $R_{DS(ON)} \times Q_{OSS}$  has been reduced by 19% compared to that of competitor's 40 V MOSFETs. [Note 2]

## 3 Wide variety of packages

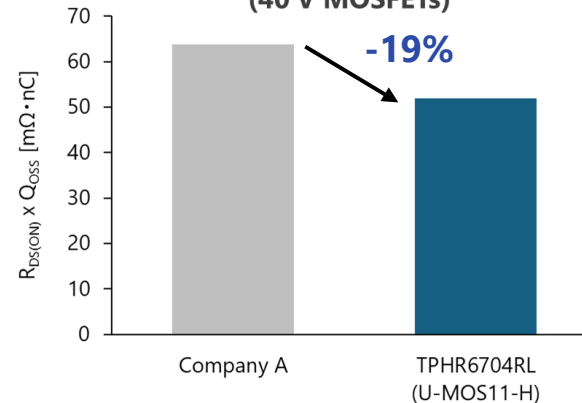
In addition to SOP Advance(N) package, double side cooling DSOP Advance package with same land pattern is available. Suitable packages for various applications can be selected.

Comparison of on-resistance  
(40 V MOSFETs)



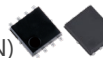


[Note 1] Toshiba internal comparison

Comparison of  $R_{DS(ON)} \times Q_{OSS}$   
(40 V MOSFETs)



[Note 2] Comparison with competitor's product with equivalent ratings.  
As of October, 2025. Based on Toshiba's measurement data.

### Lineup

Part number	TPHR6503PL	TPHR6704RL	TPWR6003PL	TPWR8004PL
Package	SOP Advance / SOP Advance(N) 	SOP Advance(N) 	DSOP Advance 	
Package size [mm]	5 x 6 / 4.9 x 6.1	4.9 x 6.1	5 x 6	
$V_{DS}$ [V]	30	40	30	40
$I_D$ [A]	150 (393*)	420	150 (412*)	150 (340*)
$R_{DS(ON)}$ [mΩ] @ $V_{GS} = 10$ V	Typ.	0.41	0.52	0.36
	Max	0.65	0.67	0.60
Generation	U-MOSIX-H	U-MOS11-H	U-MOSIX-H	U-MOSIX-H

\*: Silicon limit

[Return to Block Diagram TOP](#)

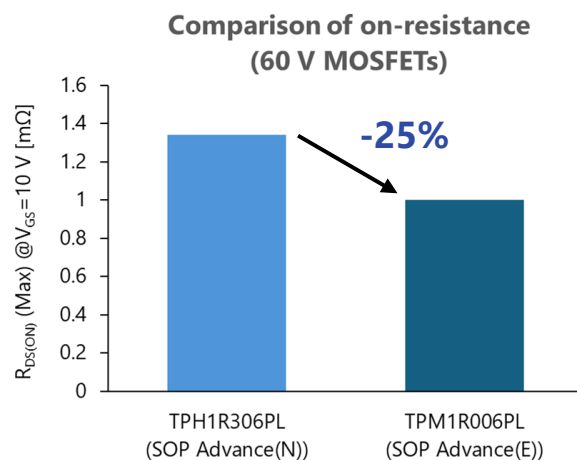
Value provided

Improved on-resistance and output charge characteristic contribute to realizing the set with high efficiency.

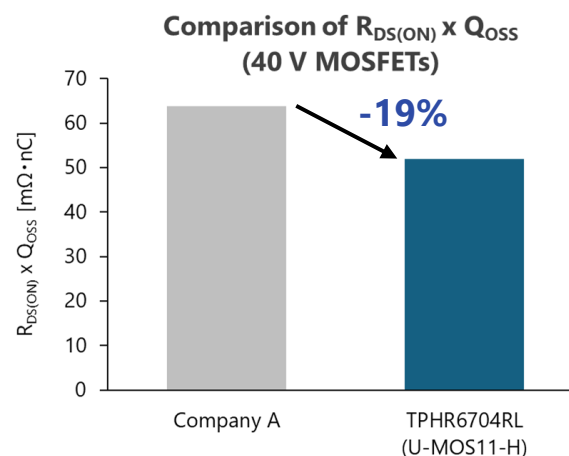
## 1 Low on-resistance

Reduction of  $R_{DS(ON)}$  makes heat generation and power consumption small.

$R_{DS(ON)}$  has been reduced by 25% compared to Toshiba's existing 60 V MOSFETs. [Note 1]



[Note 1] Toshiba internal comparison





[Note 2] Comparison with competitor's product with equivalent ratings.  
As of October, 2025. Based on Toshiba's measurement data.

## 2 Small output charge $Q_{OSS}$

The  $Q_{OSS}$  is small and contributes to the reduction of output charge loss.

The  $R_{DS(ON)} \times Q_{OSS}$  has been reduced by 19% compared to that of competitor's 40 V MOSFETs. [Note 2]

### Lineup

Part number	TPHR6704RL	TPM1R006PL
Package	SOP Advance(N) 4.9 x 6.1 mm 	SOP Advance(E) 4.9 x 6.1 mm 
$V_{DS}$ [V]	40	60
$I_D$ [A]	420	341
$R_{DS(ON)}$ [mΩ] @ $V_{GS} = 10$ V	Typ.	0.52
	Max	0.67
Generation	U-MOS11-H	U-MOSIX-H

\*: Silicon limit

[Return to Block Diagram TOP](#)

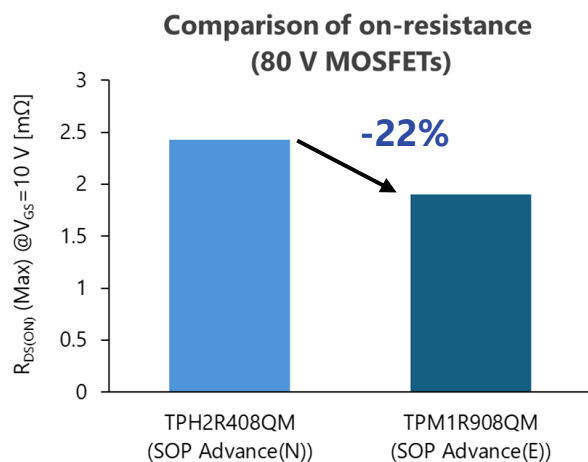
Value provided

Improved on-resistance and reverse recovery characteristic contribute to realizing the set with high efficiency.

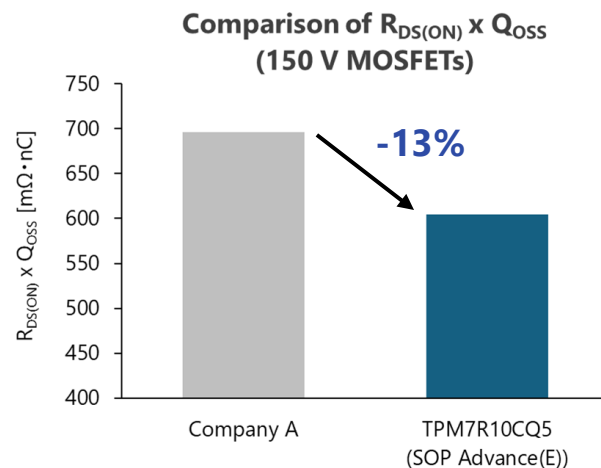
## 1 Low on-resistance

Reduction of  $R_{DS(ON)}$  makes heat generation and power consumption small.

$R_{DS(ON)}$  has been reduced by 22% compared to Toshiba's existing 80 V MOSFETs. [Note 1]



[Note 1] Toshiba internal comparison





[Note 2] Comparison with competitor's product with equivalent ratings.  
As of October, 2025. Based on Toshiba's measurement data.

## 2 Small output charge $Q_{OSS}$

The  $Q_{OSS}$  is small and contributes to the reduction of output charge loss.

The  $R_{DS(ON)} \times Q_{OSS}$  has been reduced by 13% compared to that of competitor's 150 V MOSFETs. [Note 2]

### Lineup

Part number	TPM1R908QM	TPM7R10CQ5
Package	SOP Advance(E) 4.9 x 6.1 mm	 
$V_{DS}$ [V]	80	150
$I_D$ [A]	238	120
$R_{DS(ON)}$ [mΩ] @ $V_{GS} = 10 \text{ V}$	Typ.	5.7
	Max	7.1
Generation	U-MOSX-H	U-MOSX-H

\*: Silicon limit

[◆Return to Block Diagram TOP](#)

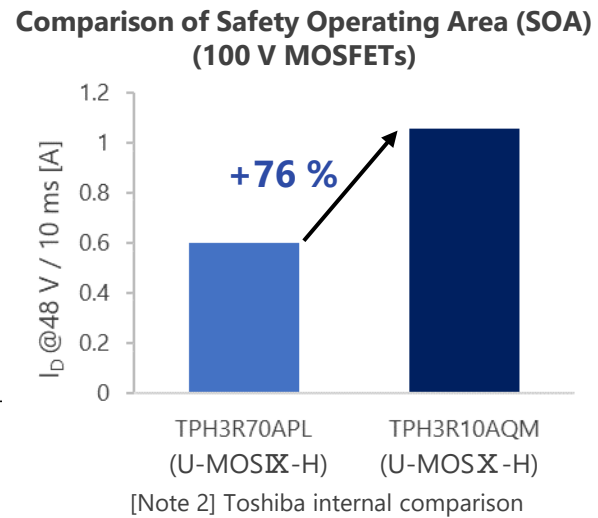
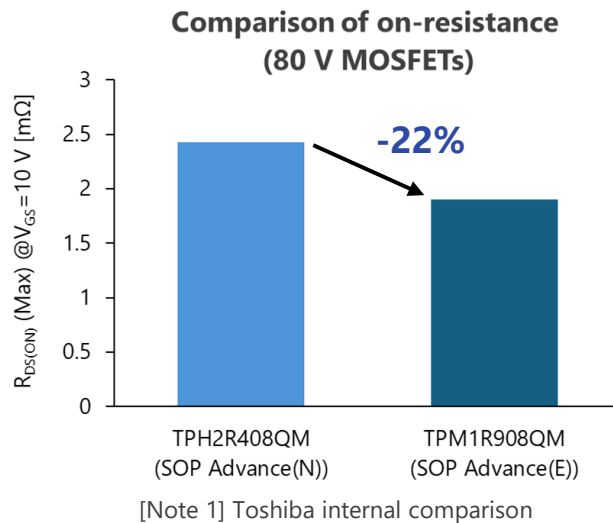
Value provided

Improved on-resistance and wide Safety Operating Area (SOA) contribute to realizing the set with high efficiency and reliability.

## 1 Low on-resistance

Reduction of  $R_{DS(ON)}$  makes heat generation and power consumption small.

$R_{DS(ON)}$  has been reduced by 22% compared to Toshiba's existing 80 V MOSFETs. [Note 1]






## 2 Wide Safety Operating Area (SOA)

The safety operating area of U-MOSX-H has increased by 76% compared to Toshiba's existing 100 V MOSFETs. [Note 2]

Expands the operating range in the transient area.

### Lineup

Part number	TPHR6503PL	TPM1R908QM	TPH3R10AQM
Package	SOP Advance(N) 4.9 x 6.1 mm 	SOP Advance(E) 4.9 x 6.1 mm 	SOP Advance(N) 4.9 x 6.1 mm 
$V_{DS}$ [V]	30	80	100
$I_D$ [A]	150 (393*)	238	120 (180*)
$R_{DS(ON)}$ [mΩ] @ $V_{GS} = 10$ V	Typ.	0.41	1.5
	Max	0.65	1.9
Generation	U-MOSIX-H	U-MOSX-H	U-MOSX-H

\*: Silicon limit

[Return to Block Diagram TOP](#)

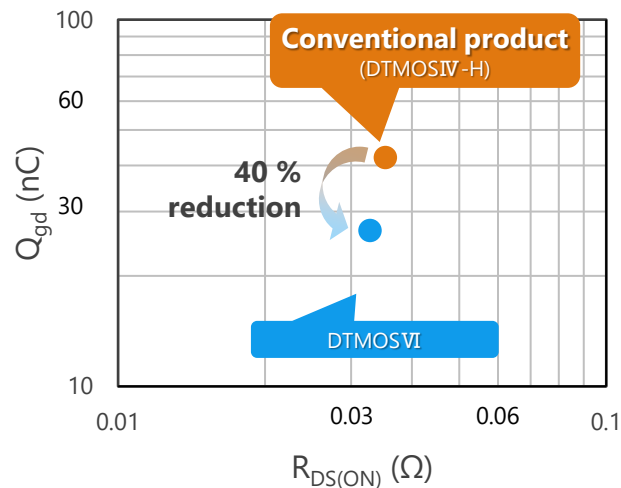
Value provided

The  $R_{DS(ON)} \times Q_{gd}$  is reduced by 40 % (compared with Toshiba's conventional products) to improve power efficiency, and contributing to miniaturization of the set.

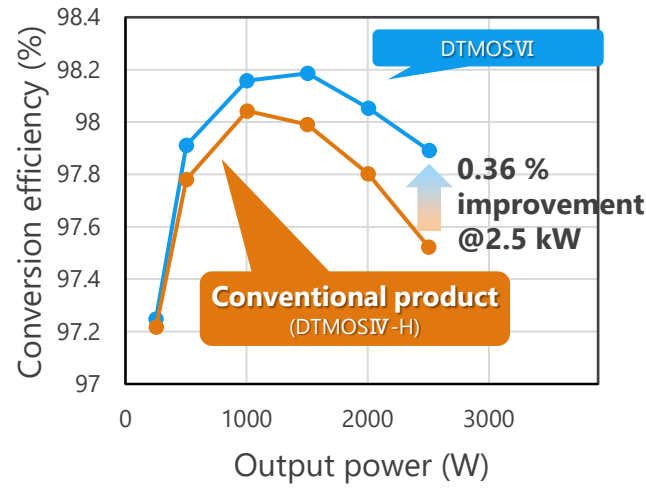
## 1 $R_{DS(ON)} \times Q_{gd}$ 40 % reduction

The  $R_{DS(ON)} \times Q_{gd}$  of figure of merit has been reduced by 40 % with gate design and process optimization.

(Comparison of DTMOSIV-H Products: Toshiba internal comparison)



(Note) Toshiba internal comparison








(Note) Toshiba internal comparison

## 2 Various package lineup

Various package line up from the TO-247-4L package with Kelvin terminal to thin surface mount type package (DFN8x8) with package thickness 0.85 mm.

### Lineup

Part number	TK040N65Z	TK040Z65Z	TK090A65Z	TK099V65Z	TK090U65Z
Package	 TO-247	 TO-247-4L	 TO-220SIS	 DFN8x8	 TOLL
$V_{DS}$ [V]	650	650	650	650	650
$I_D$ [A]	57	57	30	30	30
$R_{DS(ON)}$ [Ω] @ $V_{GS} = 10$ V	Typ.	0.033	0.033	0.075	0.080
	Max	0.040	0.040	0.090	0.099
Polarity	N-ch	N-ch	N-ch	N-ch	N-ch
Generation	DTMOSVI	DTMOSVI	DTMOSVI	DTMOSVI	DTMOSVI

[Return to Block Diagram TOP](#)

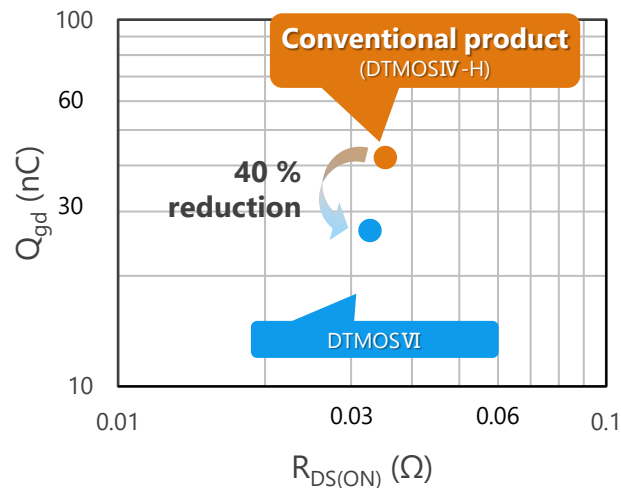
Value provided

The  $R_{DS(ON)} \times Q_{gd}$  is reduced by 40 % (compared with Toshiba's conventional products) to improve power efficiency, and contributing to miniaturization of the set.

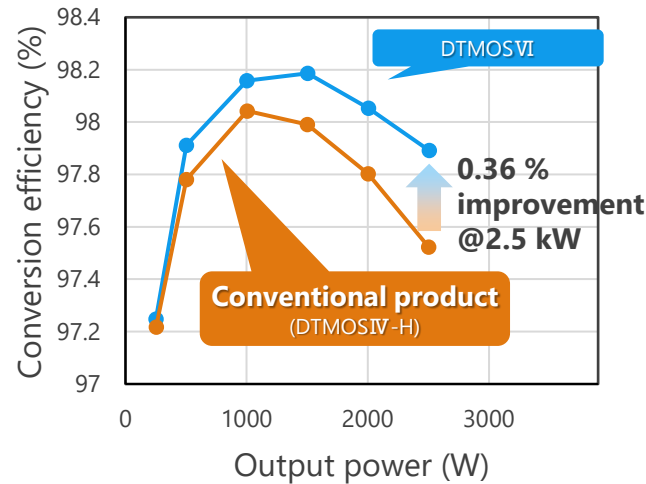
## 1 $R_{DS(ON)} \times Q_{gd}$ 40 % reduction

The  $R_{DS(ON)} \times Q_{gd}$  of figure of merit has been reduced by 40 % with gate design and process optimization.

(Comparison of DTMOSIV-H Products: Toshiba internal comparison)



(Note) Toshiba internal comparison









(Note) Toshiba internal comparison

## 2 Various package lineup

Various package lineup from the TO-247-4L package with Kelvin terminal to thin surface mount type package (DFN8x8) with package thickness 0.85 mm.

### Lineup

Part number	TK110N65Z	TK110Z65Z	TK110A65Z	TK125V65Z	TK110U65Z	TK155U65Z
Package						
$V_{DS}$ [V]	650	650	650	650	650	650
$I_D$ [A]	24	24	24	24	24	18
$R_{DS(ON)}$ [Ω] @ $V_{GS} = 10$ V	Typ. 0.092 Max 0.11	Typ. 0.092 Max 0.11	Typ. 0.092 Max 0.11	Typ. 0.105 Max 0.125	Typ. 0.086 Max 0.11	Typ. 0.122 Max 0.155
Polarity	N-ch	N-ch	N-ch	N-ch	N-ch	N-ch
Generation	DTMOSVI	DTMOSVI	DTMOSVI	DTMOSVI	DTMOSVI	DTMOSVI

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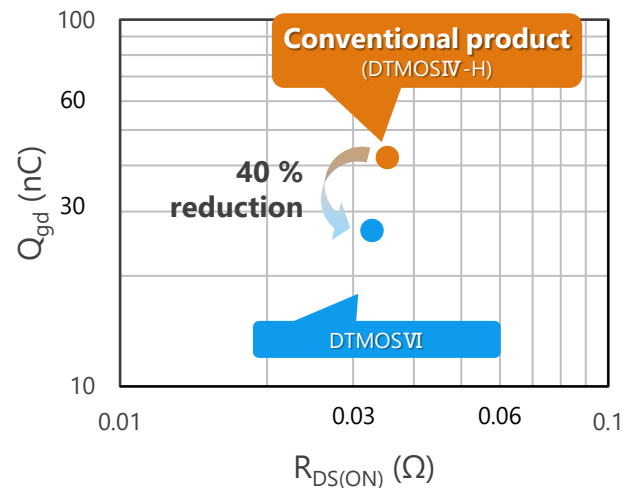
Value provided

The  $R_{DS(ON)} \times Q_{gd}$  is reduced by 40 % (compared with Toshiba's conventional products) to improve power efficiency, and contributing to miniaturization of the set.

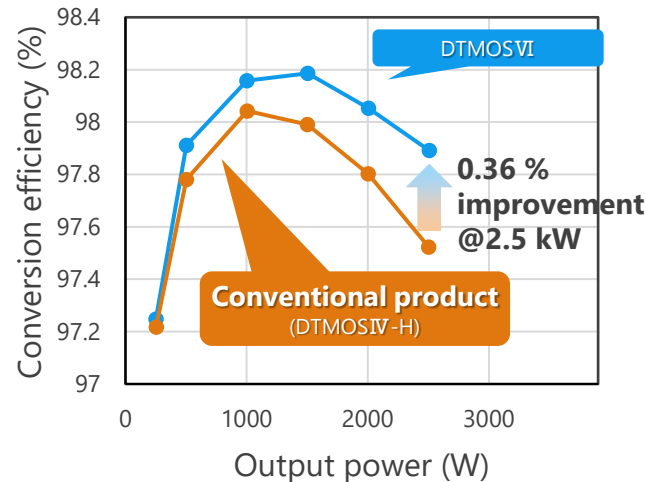
## 1 $R_{DS(ON)} \times Q_{gd}$ 40 % reduction

The  $R_{DS(ON)} \times Q_{gd}$  of figure of merit has been reduced by 40 % with gate design and process optimization.

(Comparison of DTMOSIV-H Products: Toshiba internal comparison)



(Note) Toshiba internal comparison






(Note) Toshiba internal comparison

## 2 Various package lineup

Various package lineup from the TO-247-4L package with Kelvin terminal to thin surface mount type package (DFN8x8) with package thickness 0.85 mm.

### Lineup

Part number	TK024N60Z1	TK080N60Z1	TK125A60Z1	TK165V60Z1
Package	TO-247 		TO-220S 	DFN8x8 
$V_{DS}$ [V]	600	600	600	600
$I_D$ [A]	80	30	20	16
$R_{DS(ON)}$ [Ω] @ $V_{GS} = 10$ V	Typ.	0.02	0.067	0.105
	Max	0.024	0.08	0.125
Polarity	N-ch	N-ch	N-ch	N-ch
Generation	DTMOSVI	DTMOSVI	DTMOSVI	DTMOSVI

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Value provided

The performance index  $R_{DS(ON)} \times Q_{gd}$ , which shows switching characteristics, is reduced. This contributes to lower loss of power supply in application.

## 1 Low $R_{DS(ON)} \times Q_{gd}$

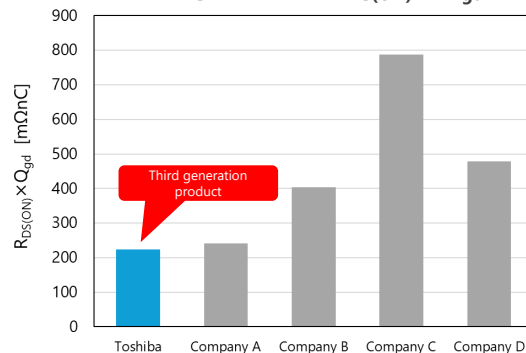
For Toshiba's third generation products, the performance index  $R_{DS(ON)} \times Q_{gd}$ , which shows the relation between conduction loss and switching loss, is reduced by optimizing its cell structure.

## 2 Wide $V_{GS}$ specification

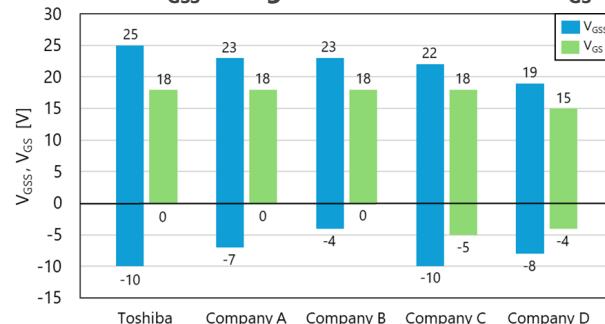
The specification of the gate-source voltage is -10 to 25 V, which is wider than that of other companies' products [Note], allows a wider margin for the drive voltage and makes gate drive design considering overshoot easier. (Recommended drive voltage: 18 V)

## 3 Built-in Schottky barrier diode





Built-in Schottky barrier diode reduces  $V_{DSF}$  during reverse conduction to 1.35 V (typ.). In addition, by energizing the Schottky barrier diode, fluctuation in  $R_{DS(ON)}$  caused by the spread of defects is suppressed.

Comparison of  $R_{DS(ON)} \times Q_{gd}$ 

Measurement conditions

 $R_{DS(ON)}$ :  $V_{GS} = 18 \text{ V}$ ,  $I_D = 20 \text{ A}$ ,  $T_a = 25 \text{ }^\circ\text{C}$  $Q_{gd}$ :  $V_{DD} = 400 \text{ V}$ ,  $V_{GS} = 18 \text{ V}$ ,  $I_D = 20 \text{ A}$ ,  $T_a = 25 \text{ }^\circ\text{C}$  $V_{GS}$  ratings and Recommended  $V_{GS}$ 

Lineup

Part number	TW027U65C	TW048U65C	TW083U65C	TW015Z65C	TW027Z65C	TW048Z65C
Package	TOLL	 Top view	 Bottom view	TO-247-4L(X)	 Top view	 Bottom view
$V_{DS}$ [V]	650	650	650	650	650	650
$I_D$ [A]	57	39	28	100	58	40
$R_{DS(ON)}$ [ $\Omega$ ] @ $V_{GS} = 18 \text{ V}$	Typ.	0.027	0.048	0.083	0.015	0.027
	Max	0.040	0.071	0.124	0.022	0.038
Polarity	N-ch	N-ch	N-ch	N-ch	N-ch	N-ch

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[Note] Based on Toshiba's measurement data, as of October 2025.

Value provided

## SiC SBDs <sup>[Note1]</sup> with low loss and high efficiency are realized by adopting new metal and optimizing device design.

[Note1] SBD: Schottky barrier diode

### 1 Low forward voltage ( $V_F$ )

For Toshiba's third generation products, new metal and thin wafer technology are introduced.  $V_F = 1.2 \text{ V}$  (Typ.) is realized as compared with  $V_F = 1.45 \text{ V}$  (Typ.) of Toshiba's existing products.  $V_F$  is reduced by about 17 %.

### 2 Improvement of power supply efficiency

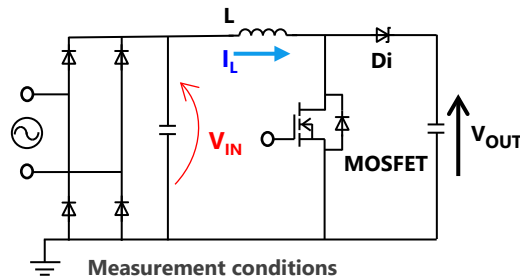
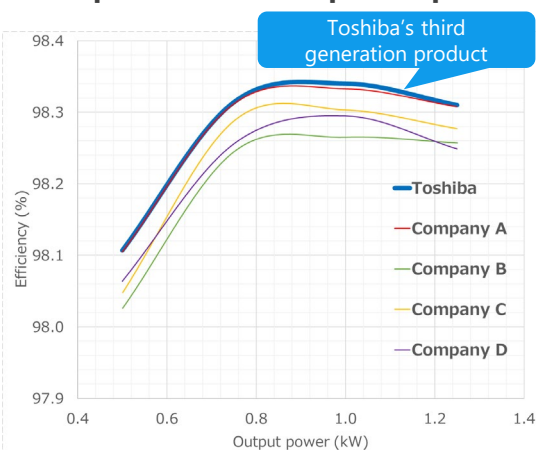
Compared with Toshiba's existing products, the trade off of  $V_F \times Q_C$  <sup>[Note2]</sup> of third generation products have improved. About 0.1 % of conversion efficiency improvement have also achieved under 800 W output condition in our test.

[Note2] The  $V_F \times Q_C$  (product of forward voltage and total charge) is an index representing the loss performance of the SiC SBD. When comparing the products with the same current rating, the smaller the index, the lower the loss.

### 3 Expansion of package series

In addition to the existing package series, DFN8x8 surface mount package type has prepared. It contributes to miniaturization and high power density of equipment.

#### Comparison between Toshiba's third generation product and competitor products



**Measurement conditions**  
 $V_{IN} = 200 \text{ V AC}$   
 $V_{OUT} = 400 \text{ V DC}$   
 $f = 65 \text{ kHz}$   
**MOSFET: TK040Z65Z**  
**MOSFET external gate resistance = 4.7  $\Omega$**   
 $T_a = 25 \text{ }^\circ\text{C}$

(Based on Toshiba's measurement data, as of July 2023)

#### Lineup

Part number	TRS24N65FB	TRS2E65H	TRS8E65H	TRS12E65H	TRS4V65H	TRS12V65H
Package	TO-247 (Center tap)	TO-220-2L			DFN8x8	
$V_{RRM}$ [V]	650	650	650	650	650	650
$I_{F(DC)}$ [A]	12 / 24 *	2	8	12	4	12
$I_{FSM}$ [A]	92 / 184 *	19	56	74	28	60
$V_F$ (Typ.) [V]	1.45 @ $I_F = 12 \text{ A}$	1.2 @ $I_F = 2 \text{ A}$	1.2 @ $I_F = 8 \text{ A}$	1.2 @ $I_F = 12 \text{ A}$	1.2 @ $I_F = 4 \text{ A}$	1.2 @ $I_F = 12 \text{ A}$

\*: Per Leg / Both Legs

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Value provided

Wide lineup of small package with high power dissipation and reverse voltage. Low  $V_F$  Schottky barrier diode suppresses negative voltage surges.

## 1 Small package with high power dissipation

Wide lineup of power dissipation.  
US2H package has low thermal resistance.

$$(R_{th(j-a)}) = 105 \text{ }^{\circ}\text{C/W [Note]}$$

## 2 Wide lineup of reverse voltage

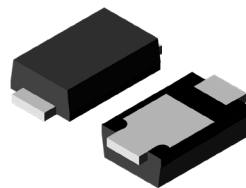
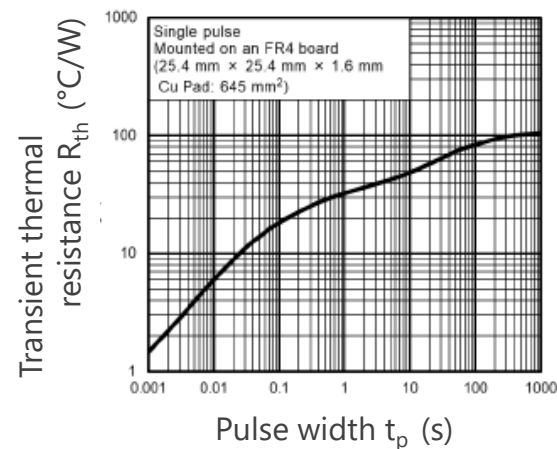
Lineup of reverse voltage  $V_R$  is 30 V, 40 V and 60 V (Max.).

## 3 Low $V_F$

Low  $V_F$  Schottky barrier diode suppresses negative voltage surges.

[Note] Assembled on FR4 circuit board (25.4 × 25.4 × 1.6 mm, Cu Pad: 25.4 x 25.4 mm)


(reference) CUHS10F60



US2H  
(2.5 x 1.4 mm)

Transient thermal resistance is low and thermal design is easy.

### Lineup

Part number	CUHS20F30	CUHS20F40	CUHS10F60	CUHS15F60	CUHS20F60	CUHS15S60	CUHS20S60
Package	US2H 						
$V_R$ [V]	30	40	60	60	60	60	60
$I_O$ [A]	2	2	1	1.5	2	1.5	2
$V_F$ (Typ.) [V] @ $I_F = 1 \text{ A}$	0.35	0.39	0.56	0.55	0.41	0.48	0.35
$I_R$ (Max) [ $\mu\text{A}$ ]	60 @ $V_R = 30 \text{ V}$	60 @ $V_R = 40 \text{ V}$	40 @ $V_R = 60 \text{ V}$	50 @ $V_R = 60 \text{ V}$	70 @ $V_R = 60 \text{ V}$	450 @ $V_R = 60 \text{ V}$	650 @ $V_R = 60 \text{ V}$

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Value provided

**Absorbs static electricity from external terminals, prevents circuit malfunction, and protects devices.**

## 1 Improved ESD pulse absorption

Improved ESD absorption compared to Toshiba's existing products. (50 % reduction in operating resistance)

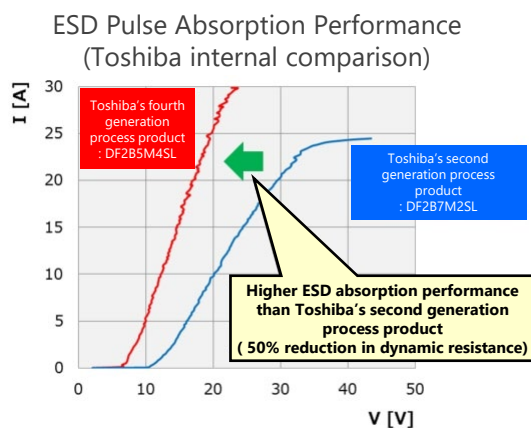
For some products, both low operating resistance and low capacitance are realized and ensures high signal protection performance and signal quality.

## 2 Suppress ESD energy by low clamp voltage

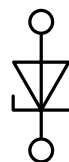
Protect the connected circuits and devices using Toshiba own technology.

## 3 Suitable for high density mounting

A variety of small packages are available.



Unidirectional




Suitable for paths such as logic signals. There are lineups of 1in1, 2in1, 4in1, 5in1, 7in1.

Bidirectional



Suitable for paths with both polar signals such as audio signals.

### Lineup

Part number	DF2B7ASL	DF2B5M4SL	DF2B6M4SL
Package	SL2 		
$V_{ESD}$ [kV]	±30	±20	±20
$V_{RWM}$ (Max) [V]	5.5	3.6	5.5
$C_t$ (Typ.) [pF]	8.5	0.2	0.2
$R_{DYN}$ (Typ.) [ $\Omega$ ]	0.2	0.5	0.5
Purpose	Power line protection	Signal line protection	

(Note) This product is an ESD protection diode and cannot be used for purposes other than ESD protection.

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Value provided

A wide lineup of packages and Zener voltage are available to meet diverse needs.

## 1 Suitable for overvoltage surge protection

It can protect not only against ESD surges but also overvoltage surges close to DC.

Surge tolerance varies depending on the series.

$P_{RSM} - t_w$  data in the data sheet is a guide. Please refer it.

## 2 Variety of package lineup

Various lineups of surface mount products.

CSLZ Series: 0.62 x 0.32 mm

CUHZ Series: 2.5 x 1.4 mm

CRx Series: 3.5 x 1.6 mm

Other packages and products are here [Link](#)

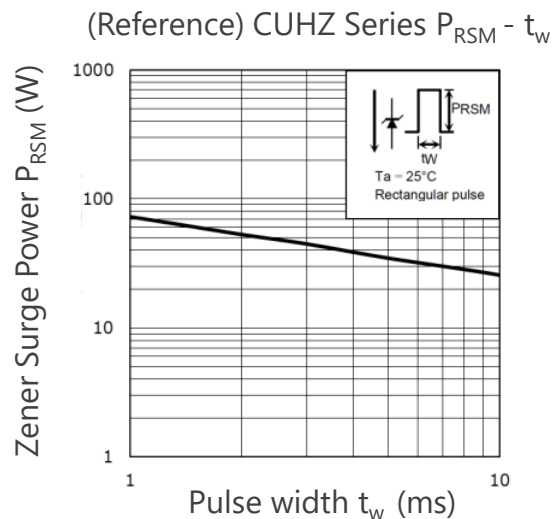
## 3 Wide lineup of $V_Z$


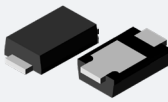

Lineup of  $V_Z$  (typ.) is from 5.6 V to 36 V.  
It can be used for required supply voltage.

For 3.3 V: CSLZ5V6, CUHZ5V6


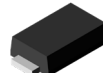

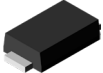


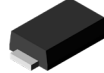

For 5 V: CSLZ6V2, CUHZ6V2, CRY62

For 12 V: CSLZ16V, CUHZ16V, CRZ16



Series	Package information
CRx Series	 S-FLAT™ 1.6 x 3.5 x 0.98 mm
CUHZ Series	 US2H (SOD-323HE) 2.5 x 1.4 x 0.6 mm
CSLZ Series	 SL2 (SOD-962) 0.62 x 0.32 x 0.3 mm

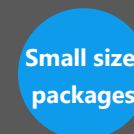
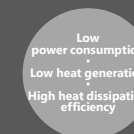
### Lineup

Power supply voltage [V]	3.3		5			12		
Part number	CSLZ5V6	CUHZ5V6	CSLZ6V2	CUHZ6V2	CRY62	CSLZ16V	CUHZ16V	CRZ16
$V_Z$ [V]	5.3 to 6.0	5.3 to 6.0	5.8 to 6.6	5.8 to 6.6	5.6 to 6.8	15.3 to 17.1	15.3 to 17.1	14.4 to 17.6
$I_Z$ [mA]	5	10	5	10	10	5	10	10
Package	 SL2 (SOD-962)	 US2H (SOD-323HE)	 SL2 (SOD-962)	 US2H (SOD-323HE)	 S-FLAT™	 SL2 (SOD-962)	 US2H (SOD-323HE)	 S-FLAT™

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# 8 Transistor output photocoupler

## TLP383 / TLP291(SE)



Value provided

**Contribute to the elimination of equipment maintenance by improving reliability and the reduction of the board footprint area.**

### 1 High current transfer ratio

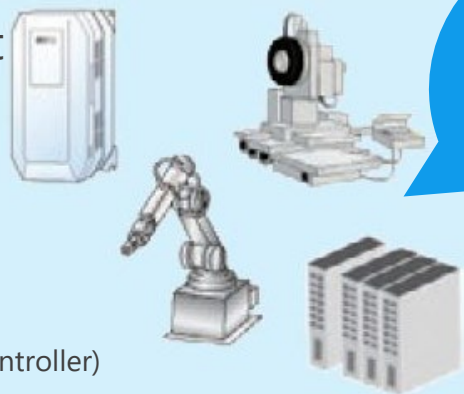
These are photo couplers of high isolation type that consists of a phototransistor optically coupled to an infrared LED. It achieves high current transfer ratio.

### 2 Wide operating temperature range

It is designed to operate even under severe ambient temperature conditions, such as inverters, robots, machinery, and high output power supplies.

#### Industrial equipment

General purpose inverter  
Servo amplifier  
Robot  
Machine Tool  
High output power supply  
Security equipment  
Semiconductor tester  
PLC (Programmable Logic Controller)  
Server



High level of  
isolation and  
noise  
blocking

#### Lineup

Part number	TLP383	TLP291(SE)
Package	4pin SO6L 	SO4 
$BV_S$ [Vrms]	5000	3750
$T_{opr}$ [°C]	-55 to 125	-55 to 110

[◆Return to Block Diagram TOP](#)

Value provided

**Photocoupler that consists of an infrared light-emitting diode and an integrated photodetector with high gain and high speed.**

## 1 High speed

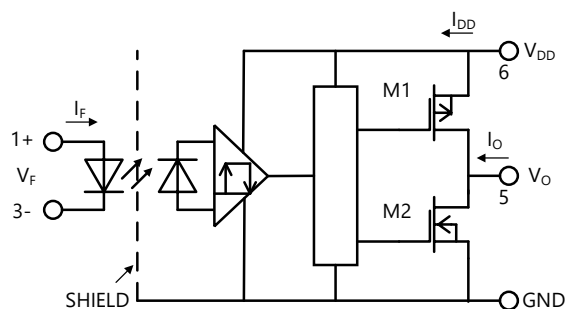
The propagation delay is 20 ns (Max) for TLP2767 and 60 ns (Max) for TLP2370. Margin design becomes easier than general phototransistor couplers.

## 2 Operating temperature is expanded to 125 °C

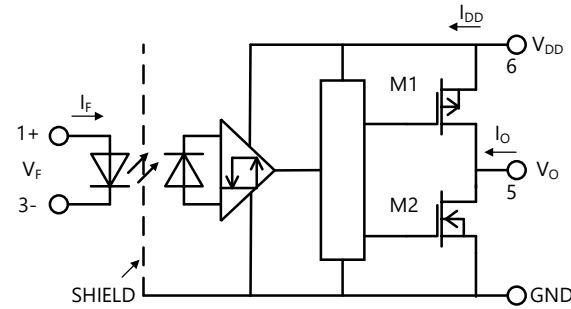
It is designed to operate even under severe ambient temperature conditions, such as inverters, robots, machinery, and high output power supplies.

## 3 Wide range of power supply voltages 2.7 to 5.5 V

The products can be used even in systems in which 3.3 V and 5.0 V are mixed, thereby possible to standardize components.





TLP2767 (Inverter logic output)



TLP2370 (Buffer logic output)

Internal Circuit

### Lineup

Part number	TLP2767	TLP2370
Package	SO6L 	5pin SO6 
$V_{DD}$ [V]	2.7 to 5.5	2.7 to 5.5
$I_{DD}$ (Max) [mA]	2.5	0.4
$t_{pd}$ (Max) [ns]	20	60
$BV_S$ [Vrms]	5000	3750
$T_{opr}$ [°C]	-40 to 125	-40 to 125

[◆Return to Block Diagram TOP](#)

Value provided

Digital isolator for high-speed logic circuits, suitable for isolating communication lines.

## 1 High speed response

It is a four-channel high speed logic digital isolator and realizes the data rate of 150 Mbps (Max).

## 2 High noise immunity

Magnetic coupling type can block the common-mode noise and realize stable operation in case of large dv/dt noise is applied between the input and output during switching.

Common Mode Transient Immunity (CMTI)  
=  $\pm 200$  [kV/ $\mu$ s] (Typ.)

## 3 High reliability

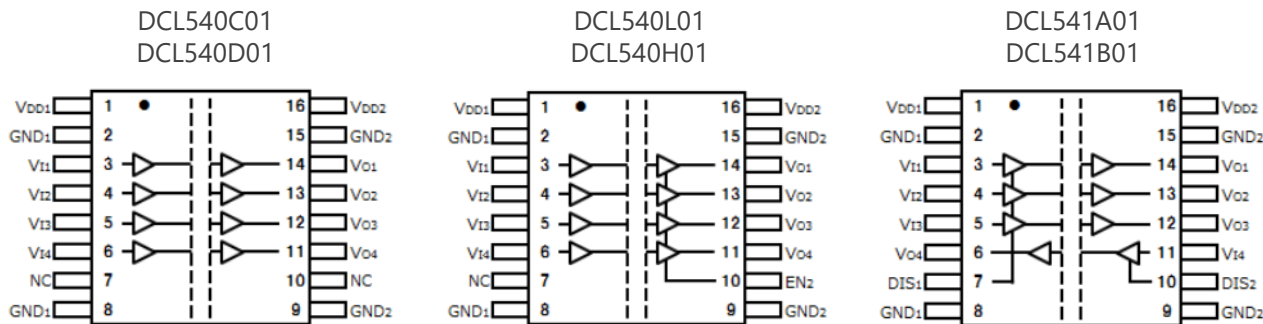
Double isolation structure provides high dielectric strength and reliability.

Reinforced isolation 5000 [Vrms]


Estimated isolation life >70 years [Note]

[Note] Estimated by TDDb (Time Dependent Dielectric Breakdown) test

### Circuit configuration



### Lineup

Part number	DCL540C01	DCL540D01	DCL540L01	DCL540H01	DCL541A01	DCL541B01
Package	SOIC16-W 					
Channel	4 (Forward: 4, Reverse: 0)				4 (Forward: 3, Reverse: 1)	
BV <sub>s</sub> [Vrms]	5000					
T <sub>opr</sub> [°C]	-40 to 110					
Default output State	Low	High	Low	High	Low	High
Control signal	-		Output Enable		Input Disable	

[◆Return to Block Diagram TOP](#)

Value provided

Low on-resistance, small and high power dissipation packages contribute to miniaturization and low power consumption of the systems.

## 1 Low loss (reduced chip resistance)

Using low chip resistance technology to contribute to reduced power consumption systems.

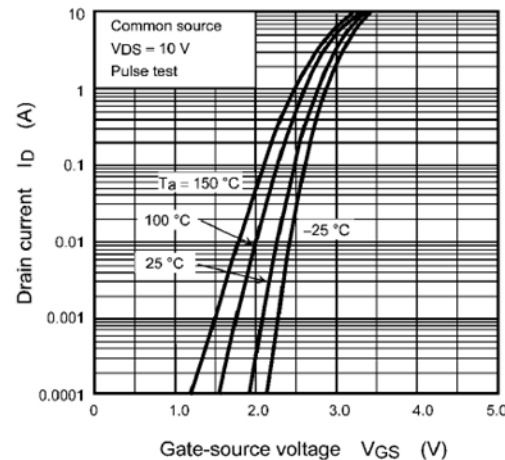
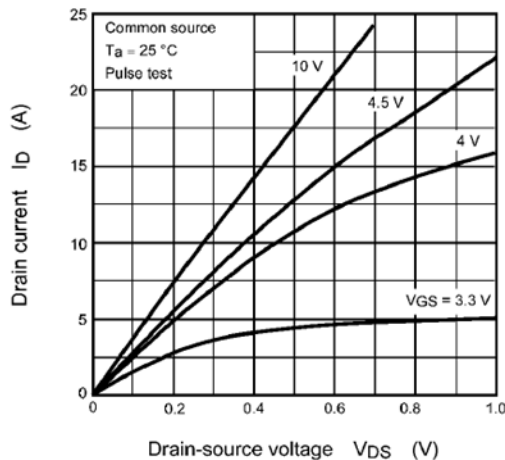
## 2 Small and high heat dissipating package

Small and high heat dissipating packages (UDFN6B, SOT-23F) contribute to space saving during mounting.



## 3 Low voltage drive

Power consumption of the set can be reduced by low voltage drive.

SSM3K341R



Lineup

Part number	SSM6K341NU	SSM3K341R
Package	UDFN6B 	SOT-23F 
$V_{DS}$ [V]	60	60
$I_D$ [A]	6	6
$R_{DS(ON)}$ [mΩ] @ $V_{GS} = 4.5$ V	Typ. 36 Max 51	Typ. 36 Max 51
Polarity	N-ch	N-ch

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Value provided

**Contribute to system cost down, high efficiency system and development efficiency improvement.**

## 1 Built-in Arm® Cortex®-M3 CPU core

Built-in Arm Cortex-M3 core with Thumb® instruction set improves energy efficiency. Various development tool and their partners allow users many options.

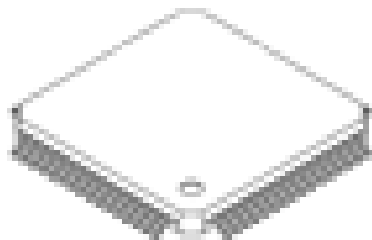
## 2 Suitable for sensing analog signal

Built-in multichannel AD converters and CPU system execute sensing data processing efficiently at low cost.

## 3 Small package and low power consumption

Cortex-M3 and original NANOFLASH™ technology bring to the small package and low power consumption. They contribute to reduction of board area and power consumption.

TPM372FWUG



Package: LQFP64-P-1010-0.50E

Lineup

Part number	TPM372FWUG
Maximum operation frequency	80 MHz
ROM	128 KB
RAM	6 KB
Timer/Counter	8ch
UART/SIO	4ch
AD converters	11ch (12bit)
Three-phase PWM output	1ch

[◆Return to Block Diagram TOP](#)

Value provided

**One hall sine wave PWM control driver for three-phase brushless DC motor. It is suitable for controlling server fans.**

## 1 Built-in one hall phase difference detection circuit

Monitoring one hall element output voltage and controlling a motor. Possible to reduce motor unit BOM.

## 2 Built-in closed loop speed control

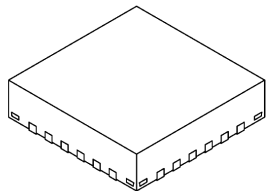
NVM <sup>[Note]</sup> is implemented. It realizes closed loop speed control function without an external MCU. It contributes to reduce system cost.

[Note] No-volatile memory

## 3 Small package

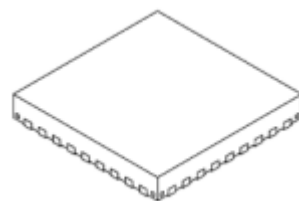
VQFN24 and WQFN36 are suitable for mounting limited space.

TC78B025FTG / TC78B027FTG



P-VQFN24-0404-0.50-002 /  
P-VQFN24-0404-0.50-003  
(4 x 4 x 0.9 mm)

TC78B009FTG



P-WQFN36-0505-0.50-001  
(5 x 5 x 0.8 mm)

### Lineup

Part number	TC78B025FTG	TC78B027FTG	TC78B009FTG
Operation voltage [V]	4.5 to 16	5 to 16	5.5 to 27
Drive type	Sine wave PWM drive		PWM drive
Others	1 hole element input position detection		Sensorless
	Closed loop speed control function, configurable speed curve		
	Standby mode		
	Soft start		
Package	Built-in driver (3.5 A (Max))	Built-in pre driver for N-ch MOSFET drive	
	P-VQFN24-0404-0.50-002	P-VQFN24-0404-0.50-003	P-WQFN36-0505-0.50-001

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Value provided

**Electronic fuse (eFuse IC) can be used repeatedly to protect circuits from abnormal conditions such as overcurrent and overvoltage.**

## 1 Can be used repeatedly

When overcurrent flows through the electronic fuse (eFuse IC), the internal detection circuit operates and switches off the internal MOSFET. It is not destroyed by a single overcurrent and can be used repeatedly.

## 2 IEC 62368-1 certified

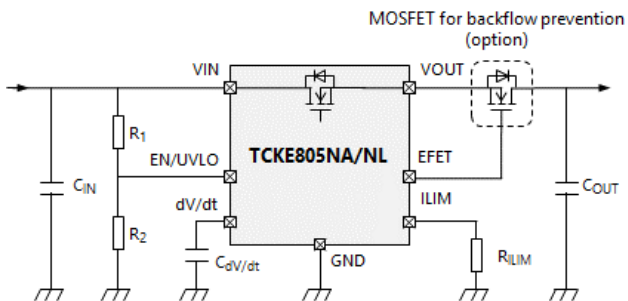
Toshiba's eFuse ICs are certified to the international safety standard IEC 62368-1 (G9: Integrated circuit (IC) current limiters) and contribute to robust protection and simplification of circuit design.

## 3 Various protection functions

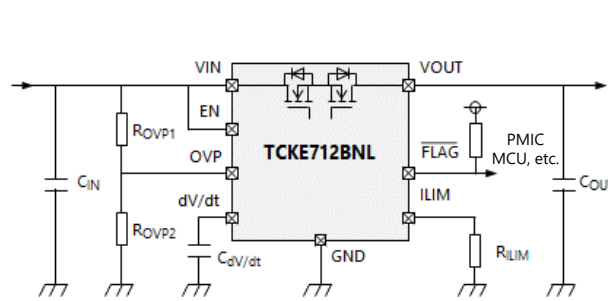
TCKE8 Series: Short-circuit protection, overcurrent protection, overcurrent clamp function, overvoltage clamp function, thermal shut down, inrush current suppression, backflow prevention (optional), etc.

TCKE7 Series: Short-circuit protection, overcurrent protection, overvoltage protection, thermal shut down, FLAG signal output, backflow prevention (built-in), etc.

Reference circuit example of TCKE8 Series



Reference circuit example of TCKE7 Series



Lineup

Part number	TCKE800NA/NL	TCKE805NA/NL	TCKE812NA/NL	TCKE712BNL
Package	WSO10B 3.0 x 3.0 x 0.75 mm			WSO10 3.0 x 3.0 x 0.75 mm
$V_{IN}$ [V]	4.4 to 18			4.4 to 13.2
$R_{ON}$ (Typ.) [mΩ]	28			53
Return function	NA: Automatic return NL: Latch type (external signal control)			Latch type (external signal control)
$V_{OVC}$ (Typ.) [V]	-	6.04	15.1	Adjustable

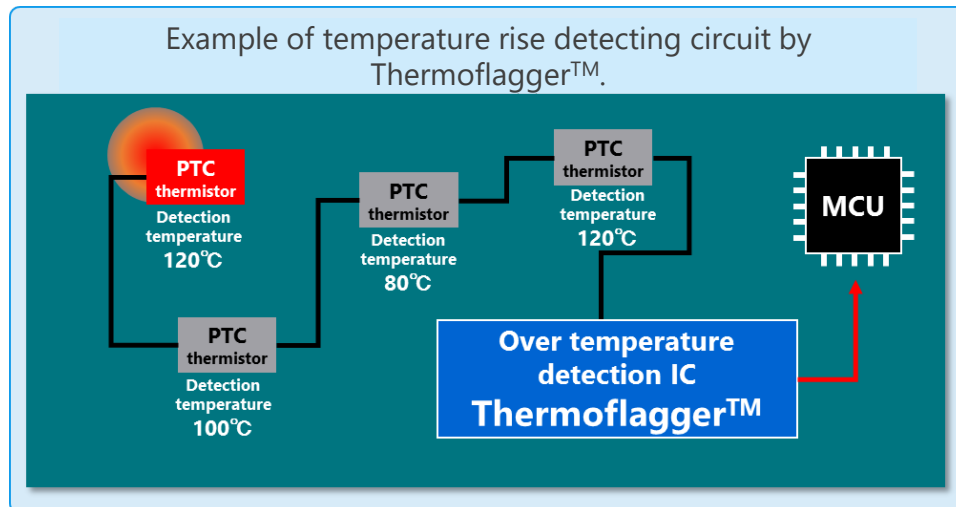
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Value provided

TCTH series can detect temperature rise at multiple points on the circuit board.

## 1 Temperature rise can be detected at multiple points


TCTH series detect voltage drop of PTC (Positive Temperature Coefficient) thermistors due to temperature rise by supplying a constant current (1  $\mu$ A or 10  $\mu$ A) to PTC thermistors. Multiple PTC thermistors connected in series enable to detect temperature rise at multiple points on the circuit board.



## 2 Low current consumption and small package

TCTH01 series has  $I_{DD} = 1.8 \mu\text{A}$  (Typ.) and TCTH02 series has  $I_{DD} = 11.3 \mu\text{A}$  (Typ.). These packages are small size ESV type.

### Lineup

Part number	TCTH011AE TCTH011BE	TCTH012AE TCTH012BE	TCTH021AE TCTH021BE	TCTH022AE TCTH022BE
Package	ESV 1.6 x 1.6 x 0.55 mm 			
$V_{DD}$ [V]	1.7 to 5.5			
$I_{DD}$ (Typ.) [ $\mu$ A]	1.8		11.3	
PTCO Output current (Typ.) [ $\mu$ A]	1	1	10	10
Abnormal latch function	-	Yes	-	Yes
Output circuit type	AE: push pull, BE: open drain			

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If you are interested in these products and have questions or comments about any of them, please do not hesitate to contact us below:

Contact address: <https://toshiba.semicon-storage.com/ap-en/contact.html>



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